



# FSC-BT630

**Bluetooth 5.2 low energy Specifications Module Datasheet**

**Version 2.0**

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## Revision History

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| 1.1     | 2019/05/14 | Corrected some erroneous decscription   | Devin Wan |
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## 1. INTRODUCTION

### Overview

FSC-BT630 is a wireless microcontroller (MCU) targeting Bluetooth 5.2 low energy applications.

Very low active RF and MCU current and low-power mode current consumption provide excellent battery lifetime and allow for operation on small coin cell batteries and in energy-harvesting applications.

FSC-BT630 contains a 32-bit ARM® Cortex®-M4 core that runs at 64 MHz as the main processor and a rich peripheral feature set that includes a unique ultra-low power sensor controller. This sensor controller is ideal for interfacing external sensors and for collecting analog and digital data autonomously while the rest of the system is in sleep mode. Thus, FSC-BT630 is great for a wide range of applications where long battery lifetime, small form factor, and ease of use is important.

It supports GAP, ATT/GATT, SMP, L2CAP profiles. It integrates Baseband controller in a small package (Integrated Ceramic antenna), so the designers can have better flexibilities for the product shapes.

### Features

- Support the Bluetooth 5.2 Specifications
- Low power
- RSSI (1 dB resolution)
- UART programming and data interface (baudrate can up to 921600bps)
- I2S audio interface
- I2C/AIO/PIO/PWM control interfaces
- Type 2 near field communication (NFC-A) tag with

wakeup-on-field and touch-to-pair capabilities

- Stamp form factor
- Temperature sensor
- Digital microphone interface (PDM)
- Up to 3x SPI master/slave(Max)
- Quadrature decoder (QDEC)
- Embedded Bluetooth stack profiles support: HID, GATT, ANCS etc
- 3x real-time counter (RTC)
- OTA upgrade support
- MFi Support
- Support External Antenna
- RoHS compliant
- FCC, CE, IC, KC and SRRCC Certified
- Power Consumption In Sleep Mode (VDD\_3V3 at 3.3V)
  - Discoverable: 100.30uA
  - LE Connection: 259.20uA
- Power Consumption In Working Mode (VDD\_3V3 at 3.3 V)
  - Discoverable: 3.44mA
  - LE Connection: 3.38mA
  - LE Connection @ 115200bps: 3.32mA

### Application

- Internet of Things (IoT)
  - Home automation
  - Sensor networks
  - Building automation
  - Industrial
  - Retail
- Personal area networks
  - Health/fitness sensor and monitor devices

- Medical devices
- Key fobs and wrist watches
- Interactive entertainment devices
  - Remote controls
  - Gaming controllers
- Beacons
  - A4WP wireless chargers and devices
  - Remote control toys
  - Computer peripherals and I/O devices:
    - Mouse/Keyboard/Multi-touch track pad/Gaming

Module picture as below showing



Figure 1: FSC-BT630 Picture

## 2. General Specification

**Table 1:** General Specifications

| Categories                     | Features             | Implementation   |
|--------------------------------|----------------------|--|
| Wireless Specification         | Bluetooth Version    | Bluetooth low energy (BLE) 5.2 Specifications  |
|                                | Chip model           | nRF52832   |
|                                | Frequency            | 2.402 - 2.480 GHz  |
|                                | Transmit Power       | +4 dBm (Maximum)   |
|                                | Receive Sensitivity  | -96 dBm sensitivity in Bluetooth low energy mode (Typical)   |
|                                | Antenna              | 2dBi Ceramic antenna   |
| Host Interface and Peripherals | Raw Data Rates (Air) | 2 Mbps Bluetooth low energy mode<br>1 Mbps, 2 Mbps supported data rates  |
|                                | UART Interface       | TX,RX,CTS/RTS(with EasyDMA)<br>General Purpose I/O<br>Default 115200,N,8,1<br>Baudrate support from 1200 to 921600<br>5, 6, 7, 8 data bit character(TBD)<br>13 (maximum – configurable) lines  |
|                                | GPIO                 | O/P drive strength (2~10 mA)<br>Pull-up resistor (13 KΩ) control<br>Read pin-level   |
|                                | I2C Interface        | Up to 2x I2C compatible 2-Wire master/slave<br>(configurable from GPIO total)<br>Up to 400 kbps(master)  |
|                                | I2S Interface        | Supports Master or Slave mode operation<br>Simultaneous bi-directional (TX and RX) audio streaming<br>Original I2S and left- or right-aligned format<br>8, 16 and 24-bit sample width<br>Low-jitter Master Clock generator<br>Various sample rates |
|                                | ADC Interface        | Analog input voltage range: 0~ VDD (VDD=3.6V)<br>8/10/12-bit resolution, 14-bit resolution with oversampling<br>6 channels (configured from GPIO total)<br>Up to 200 ksps conversion   |
| PDM                            | PWM                  | 16-bit resolution<br>8-bit prescaler and clock divider<br>Supports PWM interrupts<br>supports input capture function   |
|                                |                      | Up to two PDM microphones configured as a Left/Right pair using the same data input  |
|                                |                      | 16 kHz output sample rate, 16-bit samples<br>EasyDMA support for sample buffering<br>HW decimation filters   |

|                     |                       |  |
|---------------------|-----------------------|--|
|                     | NFC-A                 | 13.56 MHz input frequency  |
|                     | listen mode operation | Bit rate 106 kbps  |
|                     | SPI                   | 3 SPI instances(configurable from GPIO total)<br>SPI Slave and SPI Master<br>Bit rates for SPI Slave and Master - 8 Mbps |
|                     | Temperature sensor    | Temperature range is greater than or equal to operating temperature of the device<br>Resolution is 0.25 degrees          |
| Profiles            | Classic Bluetooth     | No Support   |
|                     | Bluetooth Low Energy  | GATT Client & Peripheral - Any Custom Services   |
|                     |                       | BT5.2 Specifications   |
|                     |                       | MFI Support  |
| Maximum Connections | Classic Bluetooth     | No Support   |
|                     | Bluetooth Low Energy  | 1Clients(TBD)  |
| FW upgrade          |                       | Over the Air   |
|                     |                       | Via UART   |
|                     |                       | J-link   |
| Supply Voltage      | Supply                | 1.7V ~ 3.6V  |
|                     |                       | 5.3 mA peak current in TX (0 dBm)  |
|                     |                       | 6.6 mA peak current in TX (4 dBm)(TBD)   |
|                     |                       | 5.4 mA peak current in RX  |
| Power Consumption   |                       | ~0.3uA - System OFF current, no RAM retention  |
|                     |                       | ~1.2uA - System ON base current, no RAM retention  |
|                     |                       | ~20nA - Additional RAM retention current per 4 KB RAM section  |
|                     | Power fail comparator | <4uA - Current consumption when enabled  |
| Physical            | Dimensions            | 10mm X 11.9mm X 1.8mm; Pad Pitch 1.1mm   |
| Environmental       | Operating             | -40°C to +85°C   |
|                     | Storage               | -40°C to +85°C   |
| Miscellaneous       | Lead Free             | Lead-free and RoHS compliant   |
|                     | Warranty              | One Year   |
|                     | Flash memory          | Endurance: 10000(Write/erase cycles)<br>Retention: 10 years at 40°C  |
| Humidity            |                       | 10% ~ 90% non-condensing   |
| MSL grade:          |                       | MSL 1  |
| ESD grade:          |                       | ESD HBM: 2KV   |
|                     |                       | ESD CDM: 500V  |

### 3. HARDWARE SPECIFICATION

#### 3.1 Block Diagram and PIN Diagram

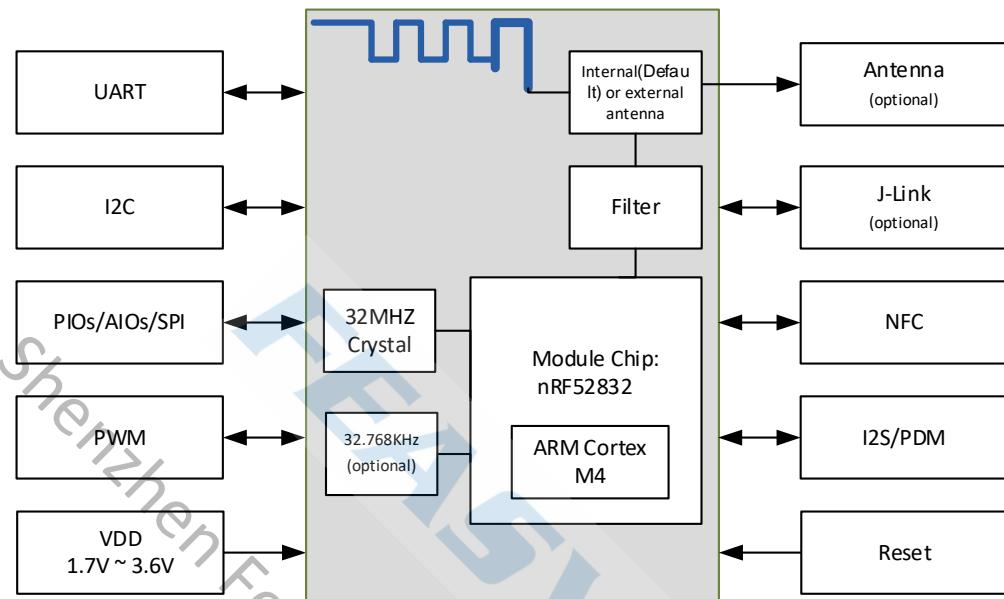


Figure 2: Block Diagram

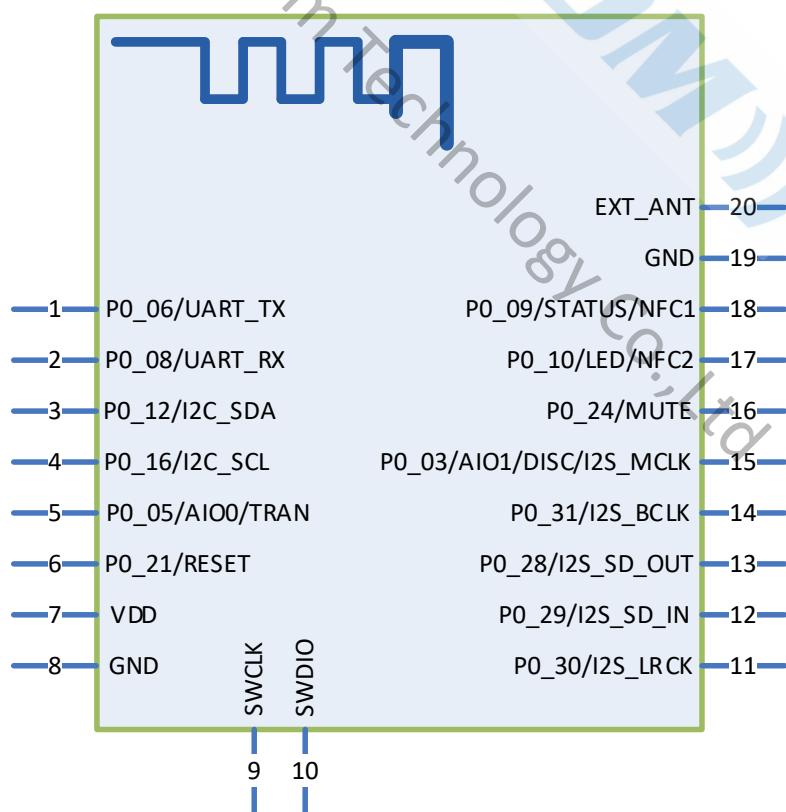


Figure 3: FSC-BT630 PIN Diagram(Top View)

### 3.2 PIN Definition Descriptions

Table 2: Pin definition

| Pin | Pin Name                     | Type | Pin Descriptions   | Notes    |
|-----|------------------------------|------|--|----------|
| 1   | P0_06/UART_TX                | O    | UART Data output   | Note 1   |
| 2   | P0_08/UART_RX                | I    | UART Data input  | Note 1   |
| 3   | P0_12/I2C_SDA                | I/O  | Programmable input/output line   | Note 2,3 |
| 4   | P0_16/I2C_SCL                | I/O  | Programmable input/output line   | Note 2,3 |
| 5   | P0_05/AIO0/TRAN              | I/O  | Programmable input/output line<br>Alternative Function 1: Analogue programmable I/O line.<br>Alternative Function 2: Host MCU change UART transmission mode.   | Note 2,4 |
| 6   | P0_21/RESET                  | I    | External reset input: Active LOW, with an inter an internal pull-up. Set this pin low reset to initial state.  | Note 3   |
| 7   | VDD_3V3                      | Vdd  | Power supply voltage 1.7 ~ 3.6V(default 3.3V)  |          |
| 8   | GND                          | Vss  | Power Ground   |          |
| 9   | SWCLK                        | I    | Serial wire debug clock input for debugand programming   |          |
| 10  | SWDIO                        | I/O  | Serial wire debug I/O for debug and programming  |          |
| 11  | P0_30/I2S_LRCK               | I/O  | Programmable input/output line<br>Alternative Function 1: I2S left right channel clock<br>Alternative Function 2: Analogue programmable I/O line.  | Note 2   |
| 12  | P0_29/I2S_SD_IN              | I    | Programmable input/output line<br>Alternative Function 1: I <sup>2</sup> S data input<br>Alternative Function 2: Analogue programmable I/O line.   | Note 2   |
| 13  | P0_28/I2S_SD_OUT             | O    | Programmable input/output line<br>Alternative Function 1: I <sup>2</sup> S data out<br>Alternative Function 2: Analogue programmable I/O line.   | Note 2   |
| 14  | P0_31/I2S_BCLK               | I/O  | Programmable input/output line<br>Alternative Function 1: I <sup>2</sup> S bit clock pin<br>Alternative Function 2: Analogue programmable I/O line.  | Note 2   |
| 15  | P0_03/AIO1/DISC/I2S_M<br>CLK | I/O  | Programmable input/output line<br>Alternative Function 1: Analogue programmable I/O line.<br>Alternative Function 2: I <sup>2</sup> S Master clock pin.<br>Alternative Function 3: Host MCU disconnect bluetooth.<br>Alternative Function 4: Analogue programmable I/O line. | Note 2,5 |
| 16  | P0_24/MUTE                   | I/O  | Programmable input/output line<br>Alternative Function: Mute Pin   | Note 6   |
| 17  | P0_10/LED/NFC2               | I/O  | Programmable input/output line<br>Alternative Function 1: LED<br>Alternative Function 2: NFC2  | Note 7   |
| 18  | P0_09/STATUS/NFC1            | I/O  | Programmable input/output line<br>Alternative Function 1: BT Status  | Note 8   |

| Alternative Function 2: NFC1 |         |     |                           |
|------------------------------|---------|-----|---------------------------|
| 19                           | GND     | Vss | Power Ground              |
| 20                           | EXT_ANT | O   | RF signal output . Note 9 |

**Module Pin Notes:**

|        |   |
|--------|---|
| Note 1 | For customized module, this pin can be work as I/O Interface.   |
| Note 2 | I2C/PWM/SPI/PDM/UART(CTS/RTS) with EasyDMA<br>(Support accomplishing the port mapping to other spare I/O Interface via modifying the firmware.)   |
| Note 3 | I2C Serial Clock and Data.<br>It is essential to remember that pull-up resistors on both SCL and SDA lines are not provided in the module and MUST be provided external to the module.  |
| Note 4 | When bluetooth connection established, UART transmission mode will be determined by PIO2's level :<br>High: Command Mode<br>Low: Throughput Mode  |
| Note 5 | When bluetooth connection established,a riving edge of PIO7 will cause disconnection with remote device.  |
| Note 6 | Audio Mute Pin-- Mute ON: High Level; Mute OFF: Low Level.  |
| Note 7 | LED(Default)-- Power On: Light Slow Shinning ; Connected: Steady Lighting.  |
| Note 8 | BT Status(Default)-- Disconnected: Low Level; Connected: High Level.  |
| Note 9 | By default, this PIN is an empty feet. This PIN can connect to an external antenna to improve the Bluetooth signal coverage.<br>If you need to use an external antenna, by modifying the module on the OR resistance to block out the on-board antenna; Or contact Feasycom for modification. |

## 4. PHYSICAL INTERFACE

### 4.1 Power Supply

The transient response of the regulator is important. If the power rails of the module are supplied from an external voltage source, the transient response of any regulator used should be 20µs or less. It is essential that the power rail recovers quickly.

This module has the following power supply features:

- On-chip LDO and DC/DC regulators
- Global System ON/OFF modes
- Individual RAM section power control for all system modes
- Analog or digital pin wakeup from System OFF
- Supervisor HW to manage power on reset, brownout, and power fail
- Auto-controlled refresh modes for LDO and DC/DC regulators to maximize efficiency
- Automatic switching between LDO and DC/DC regulator based on load to maximize efficiency

## 4.2 Reset

The module may be reset from several sources: Power-on Reset (POR), Low level on the nRESET Pin (nRST), Watchdog time-out reset (WDT), Wakeup from System OFF mode reset , Brown-out reset or Software Reset(SYSRESETREQ, CPU Reset, CHIPRST).

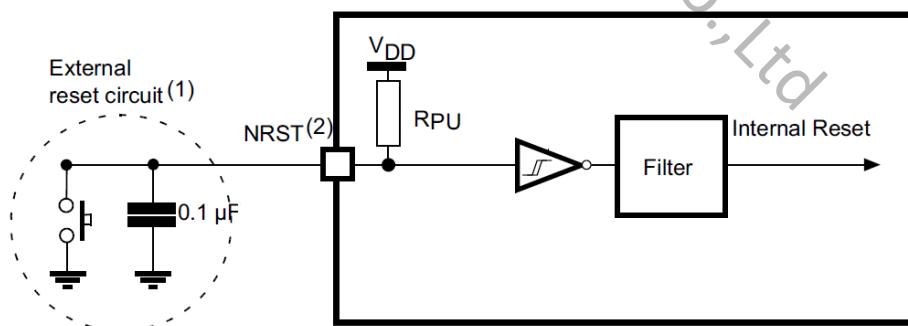
The RESET pin is an active low reset and is internally filtered using the internal low frequency clock oscillator. A reset will be performed between 1.5 and 4.0ms following RESET being active. It is recommended that RESET be applied for a period greater than 5ms.

At reset the digital I/O pins are set to inputs for bi-directional pins and outputs are tri-state. The PIOs have weak pull-ups.

**Table 3:** NRST pin characteristics

| Parameter  | Conditions                        | Min | Typ | Max | Unit |
|--|-----------------------------------|-----|-----|-----|------|
| R <sub>PU</sub> - Weak pull-up equivalent resistor <sup>(1)</sup>  | V <sub>IN</sub> = V <sub>SS</sub> | 30  | 40  | 50  | KΩ   |
| V <sub>F(NRST)</sub> <sup>(2)</sup> - NRST Input filtered pulse  |                                   | -   | -   | 100 | ns   |
| V <sub>NF(NRST)</sub> <sup>(2)</sup> - NRST Input not filtered pulse   | V <sub>DD</sub> >1.2V             | 300 | -   | -   | ns   |
| T <sub>NRST_OUT</sub> - Generated reset pulse duration   | Internal Reset source             | 20  | -   | -   | μs   |
| V <sub>POL</sub> - Nominal power level warning thresholds (falling supply voltage). Levels are configurable between Min. and Max. in 100mV increments. |                                   | 1.7 |     | 2.8 | V    |
| V <sub>BOR,OFF</sub> - Brown out reset voltage range SYSTEM OFF mode   |                                   | 1.2 |     | 1.7 | V    |
| V <sub>BOR,ON</sub> - Brown out reset voltage range SYSTEM ON mode   |                                   | 1.5 |     | 1.7 | V    |

1. The pull-up is designed with a true resistance in series with a switchable PMOS. This PMOS contribution to the series resistance must be minimum (~10% order).
2. Guaranteed by design.



1. The reset network protects the device against parasitic resets.
2. The user must ensure that the level on the NRST pin can go below the VIL(NRST) max level specified in *NRST pin characteristics*. Otherwise the reset is not taken into account by the device.

**Figure 4:** Recommended NRST pin protection

## 4.3 General Purpose Analog IO

The ADC is a differential successive approximation register (SAR) analog-to-digital converter.

Listed here are the main features of SAADC:

- 8/10/12-bit resolution, 14-bit resolution with oversampling
- Up to eight input channels
  - One channel per single-ended input and two channels per differential input
  - Scan mode can be configured with both single-ended channels and differential channels.
- Full scale input range (0 to VDD)
- Sampling triggered via a task from software or a PPI channel for full flexibility on sample frequency source from low power 32.768kHz RTC or more accurate 1/16MHz Timers
- One-shot conversion mode to sample a single channel
- Scan mode to sample a series of channels in sequence. Sample delay between channels is tacc + tconv which may vary between channels according to user configuration of tacc.
- Support for direct sample transfer to RAM using EasyDMA
- Interrupts on single sample and full buffer events
- Samples stored as 16-bit 2's complement values for differential and single-ended sampling
- Continuous sampling without the need of an external timer
- Internal resistor string
- Limit checking on the fly

## 4.4 General Purpose Digital IO

There are 13 general purpose digital IOs defined in the module. All these GPIOs can be configured by software to realize various functions, such as button controls, LED drives or interrupt signals to host controller, etc. Do not connect them if not use.

The I/O type of each I/O pins can be configured by software individually as Input or Push-pull output mode. After the chip is reset, the I/O mode of all pins is input mode with no pull-up and pull-down enable. Each I/O pin has an individual pull-up and pull-down resistor which is about 40 kΩ for VDD and Vss.

- Configurable output drive strength
- Internal pull-up and pull-down resistors
- Wake-up from high or low level triggers on all pins
- Trigger interrupt on state changes on any pin
- All pins can be used by the PPI task/event system
- One or more GPIO outputs can be controlled through PPI and GPIOTE channels
- All pins can be individually mapped to interface blocks for layout flexibility
- GPIO state changes captured on SENSE signal can be stored by LATCH register

## 4.5 I2S Interfaces

The I2S (Inter-IC Sound) module, supports the original two-channel I2S format, and left or right-aligned formats. It implements EasyDMA for sample transfer directly to and from RAM without CPU intervention.

The I2S peripheral has the following main features:

- Master and Slave mode
- Simultaneous bi-directional (TX and RX) audio streaming
- Original I2S and left- or right-aligned format
- 8, 16 and 24-bit sample width
- Low-jitter Master Clock generator
- Various sample rates

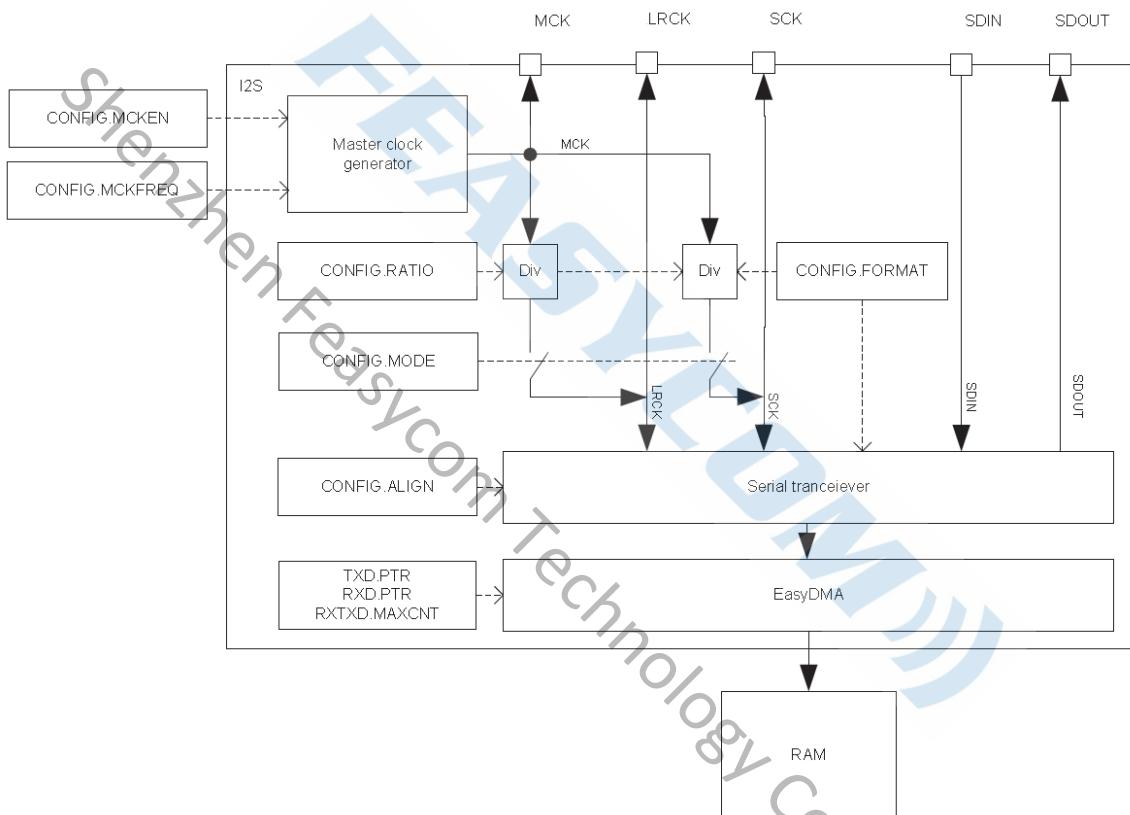
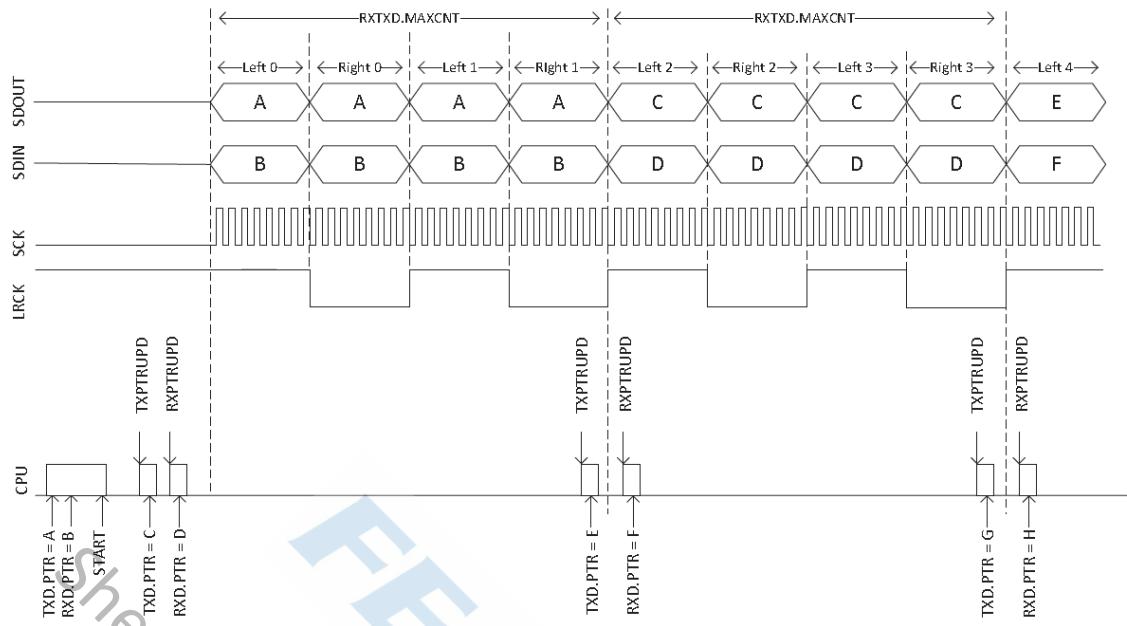
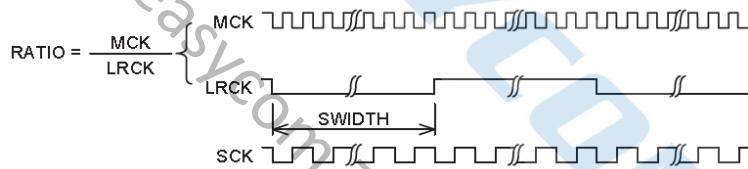


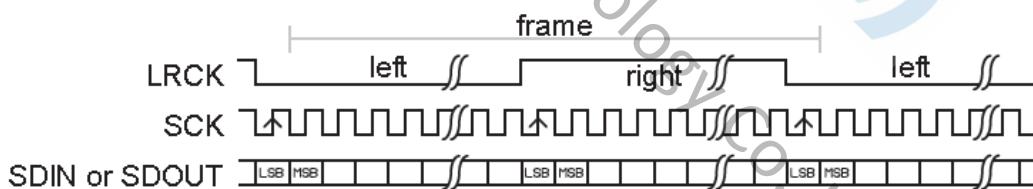
Figure 5: I2S master



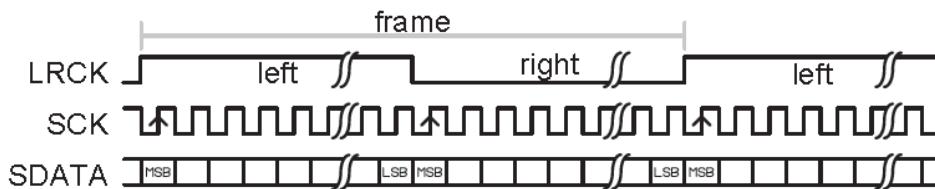
**Figure 6:** Transmitting and receiving. CONFIG.FORMAT = Aligned, CONFIG.SWIDTH = 8bit, CONFIG.CHANNELS = Stereo, RXTXD.MAXCNT = 1.



**Figure 7:** Relation between RATIO, MCK and LRCK



**Figure 8:** I2S format. CONFIG.SWIDTH equalling half-frame size



**Figure 9:** Aligned format. CONFIG.SWIDTH equalling half-frame size

## 4.6 SPI Interfaces

The SPI master provides a simple CPU interface which includes a TXD register for sending data and an RXD register for receiving data. This section is added for legacy support for now.

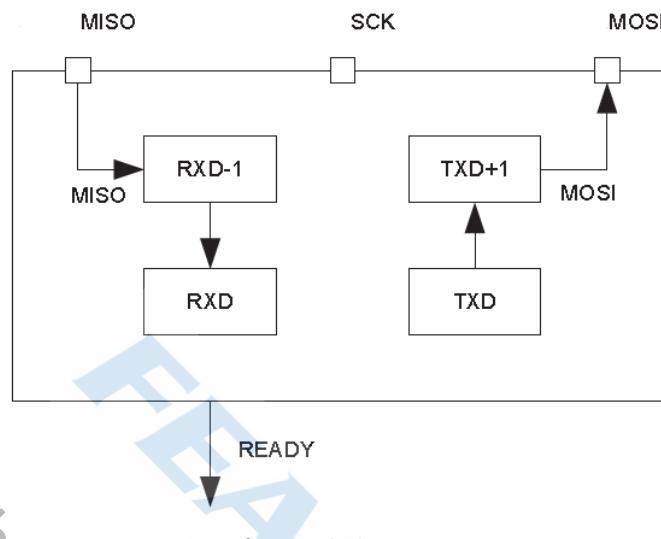


Figure 10: SPI master

The TXD and RXD registers are double-buffered to enable some degree of uninterrupted data flow in and out of the SPI master.

The SPI master does not implement support for chip select directly. Therefore, the CPU must use available GPIOs to select the correct slave and control this independently of the SPI master. The SPI master supports SPI modes 0 through 3.

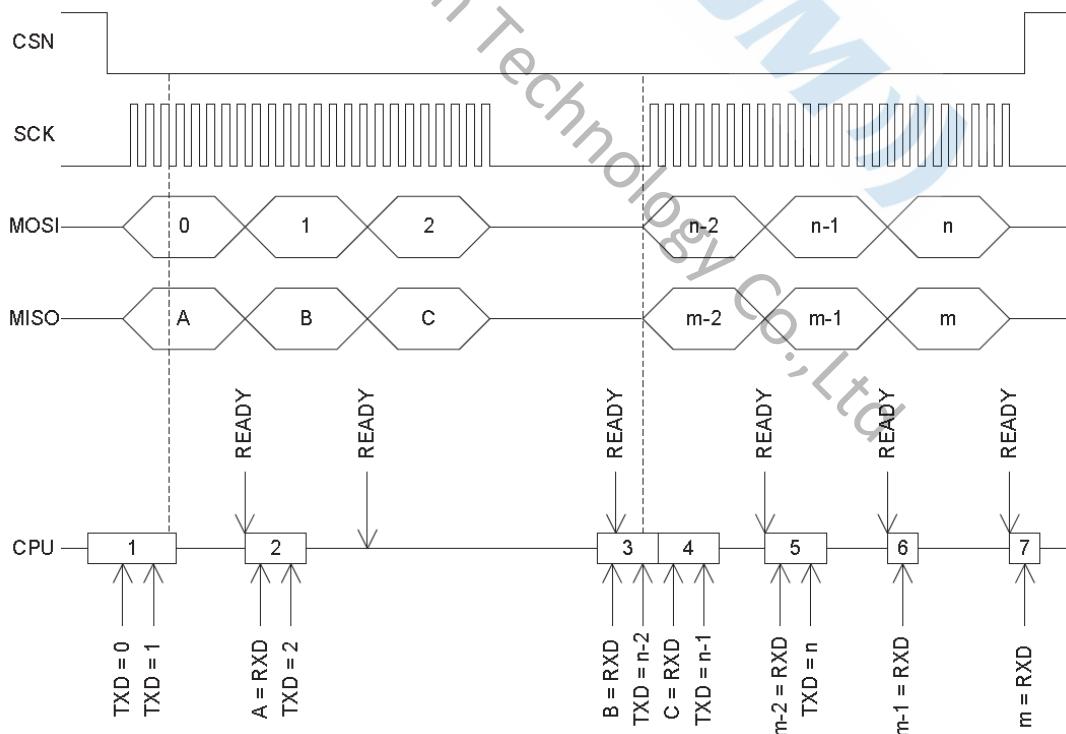


Figure 11: SPI master transaction sequence 1

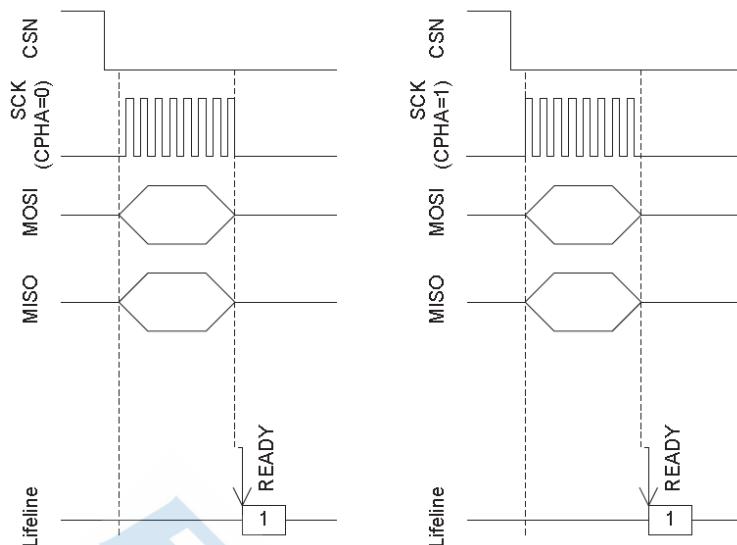


Figure 12: SPI master transaction sequence 2

## 4.7 RF Interface

For this Module, the default mode for antenna is internal ,it also has the interface for external antenna. If you need to use an external antenna, by modifying the module on the OR resistance to block out the on-board antenna; Or contact Feasycm for modification.The user can connect a 50 ohm antenna directly to the RF port.

- 2402–2480 MHz Bluetooth 5.2
- 2 Mbps Bluetooth low energy mode
- 1 Mbps, 2 Mbps supported data rates
- TX power -20 to +4 dBm in 4 dB steps
- -96 dBm sensitivity in Bluetooth® low energy mode
- Single-pin antenna interface
- RSSI (1 dB resolution)

The RADIO includes a Device Address Match unit and an interframe spacing control unit that can be utilized to simplify address white listing and interframe spacing respectively, in Bluetooth Smart and similar applications.

The RADIO also includes a Received Signal Strength Indicator (RSSI) and a bit counter. The bit counter generates events when a preconfigured number of bits have been sent or received by the RADIO.

## 4.8 Serial Interfaces

### 4.8.1 UART

FSC-BT630 provides one channels of Universal Asynchronous Receiver/Transmitters(UART)(Full-duplex asynchronous communications). The UART Controller performs a serial-to-parallel conversion on data received from the peripheral and a parallel-to-serial conversion on data transmitted from the CPU. Each UART Controller channel supports ten types of interrupts.

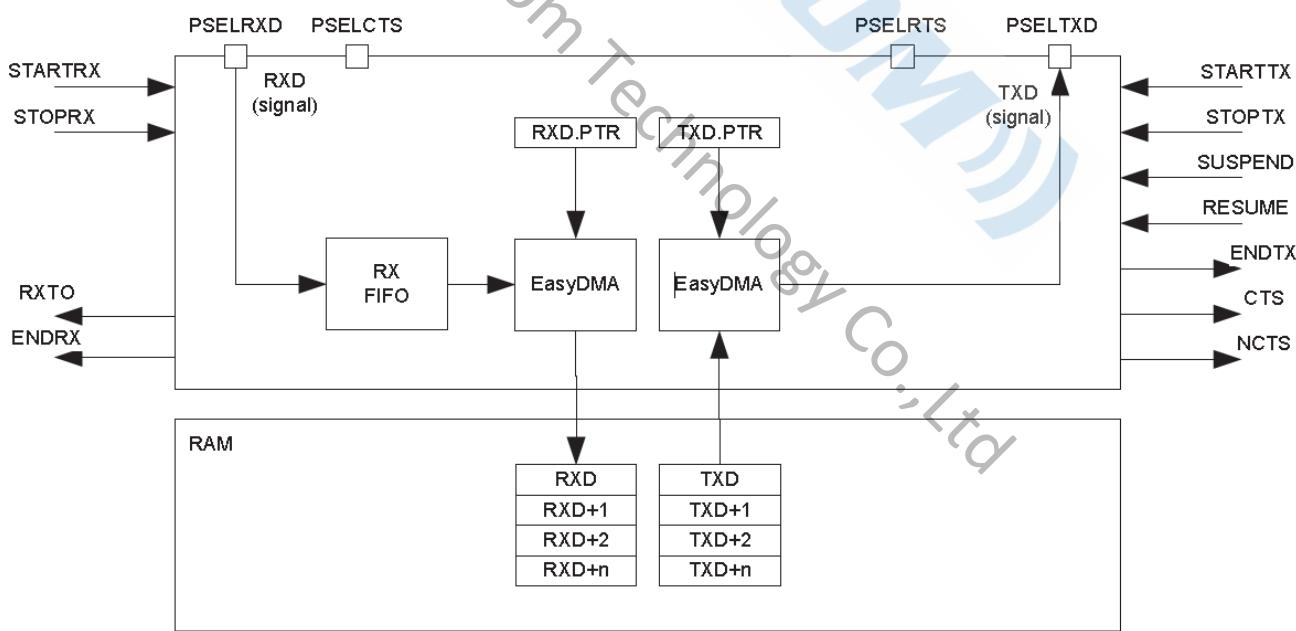
This is a standard UART interface for communicating with other serial devices. The UART interface provides a simple mechanism for communicating with other serial devices using the RS232 protocol.

When the module is connected to another digital device, UART\_RX and UART\_TX transfer data between the two devices. The remaining two signals, UART\_CTS and UART\_RTS, can be used to implement RS232 hardware flow control where both are active low indicators.

This module output is at 3.3V CMOS logic levels (tracks VCC). Level conversion must be added to interface with an RS-232 level compliant interface.

Some serial implementations link CTS and RTS to remove the need for handshaking. We do not recommend linking CTS and RTS except for testing and prototyping. If these pins are linked and the host sends data when the FSC-BT630 deasserts its RTS signal, there is significant risk that internal receive buffers will overflow, which could lead to an internal processor crash. This drops the connection and may require a power cycle to reset the module. We recommend that you adhere to the correct CTS/RTS handshaking protocol for proper operation.

- Full-duplex operation
- Automatic hardware flow control
- Parity checking and generation for the 9th data bit
- EasyDMA
- Up to 1 Mbps baudrate
- Return to IDLE between transactions supported (when using HW flow control)
- One stop bit
- Least significant bit (LSB) first



**Figure 13:** UART configuration

The GPIOs used for each UART interface can be chosen from any GPIO on the device and are independently configurable. This enables great flexibility in device pinout and efficient use of board space and signal routing.

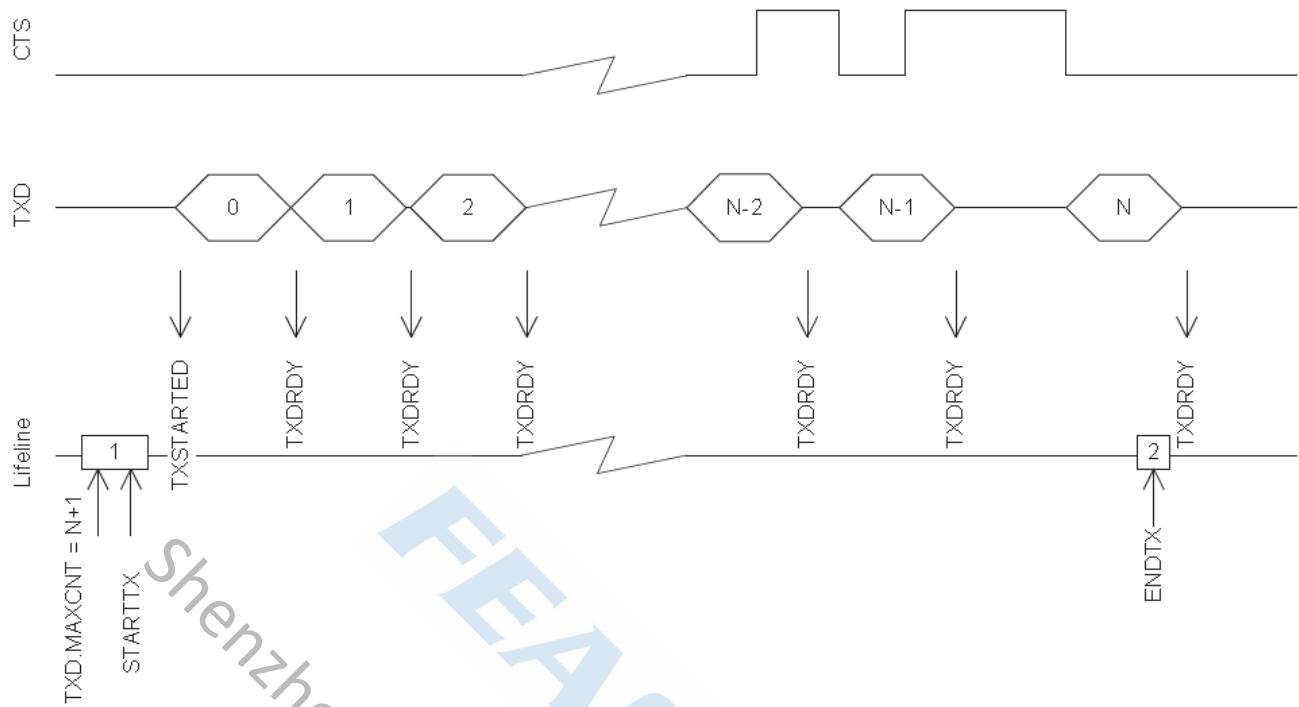


Figure 14: UART transmission

**Table 4:** Possible UART Settings

| Parameter           | Possible Values  |
|---------------------|--|
| Baudrate            | Minimum 1200 baud ( $\leq 2\%$ Error)<br>Standard 115200bps( $\leq 1\%$ Error)<br>Maximum 921600bps( $\leq 1\%$ Error) |
| Flow control        | RTS/CTS, or None   |
| Parity              | None, Odd or Even  |
| Number of stop bits | 1  |
| Bits per channel    | 8  |

When connecting the module to a host, please make sure to follow .

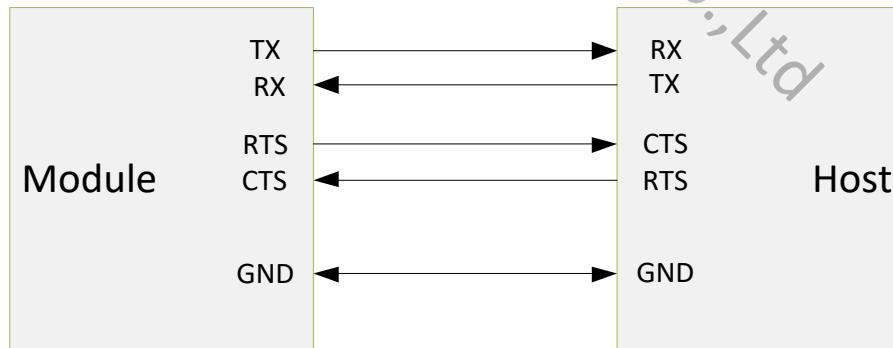


Figure 15: UART Connection

#### 4.8.2 I2C Interface

I2C is a two-wire, bi-directional serial bus that provides a simple and efficient method of data exchange between devices. The I2C standard is a true multi-master bus including collision detection and arbitration that prevents data corruption if two or more masters attempt to control the bus simultaneously.

Data is transferred between a Master and a Slave synchronously to SCL on the SDA line on a byte-by-byte basis. Each data byte is 8-bit long. There is one SCL clock pulse for each data bit with the MSB being transmitted first. An acknowledge bit follows each transferred byte. Each bit is sampled during the high period of SCL; therefore, the SDA line may be changed only during the low period of SCL and must be held stable during the high period of SCL. A transition on the SDA line while SCL is high is interpreted as a command (START or STOP). Please refer to the following figure for more details about I2C Bus Timing.

The device on-chip I2C logic provides the serial interface that meets the I2C bus standard mode specification. The I2C port handles byte transfers autonomously. The I2C H/W interfaces to the I2C bus via two pins: SDA and SCL. Pull up resistor is needed for I2C operation as these are open drain pins. When the I/O pins are used as I2C port, user must set the pins function to I2C in advance.

The I2C master is compatible with I2C operating at 100 kHz and 400 kHz.

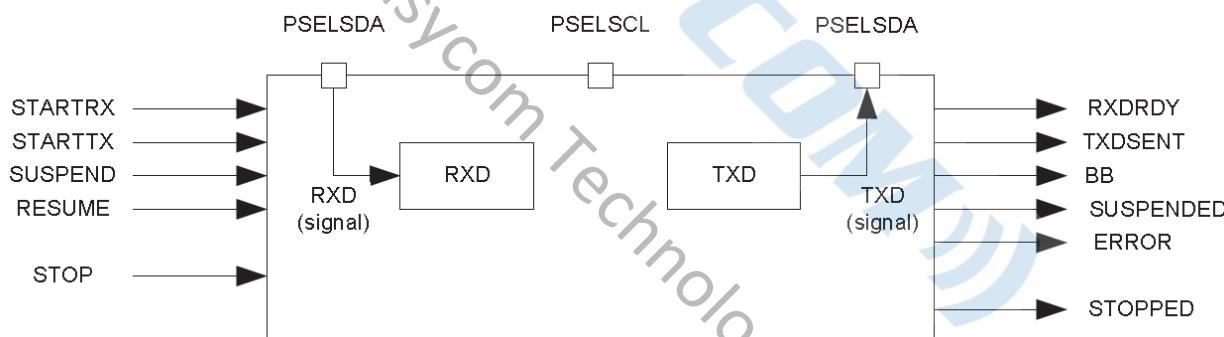


Figure 16: I2C master's main features

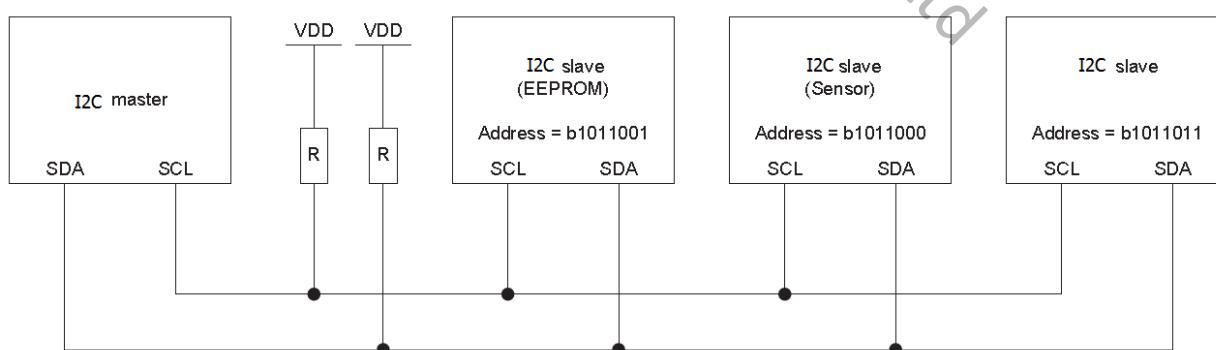


Figure 17: A typical I2C setup comprising one master and three slaves

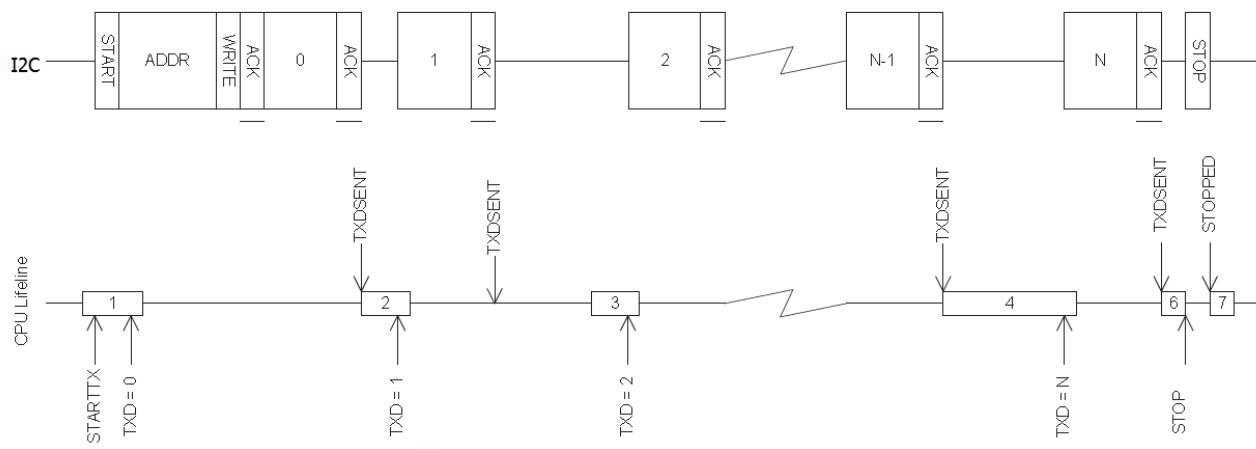


Figure 18: The I2C master writing data to a slave

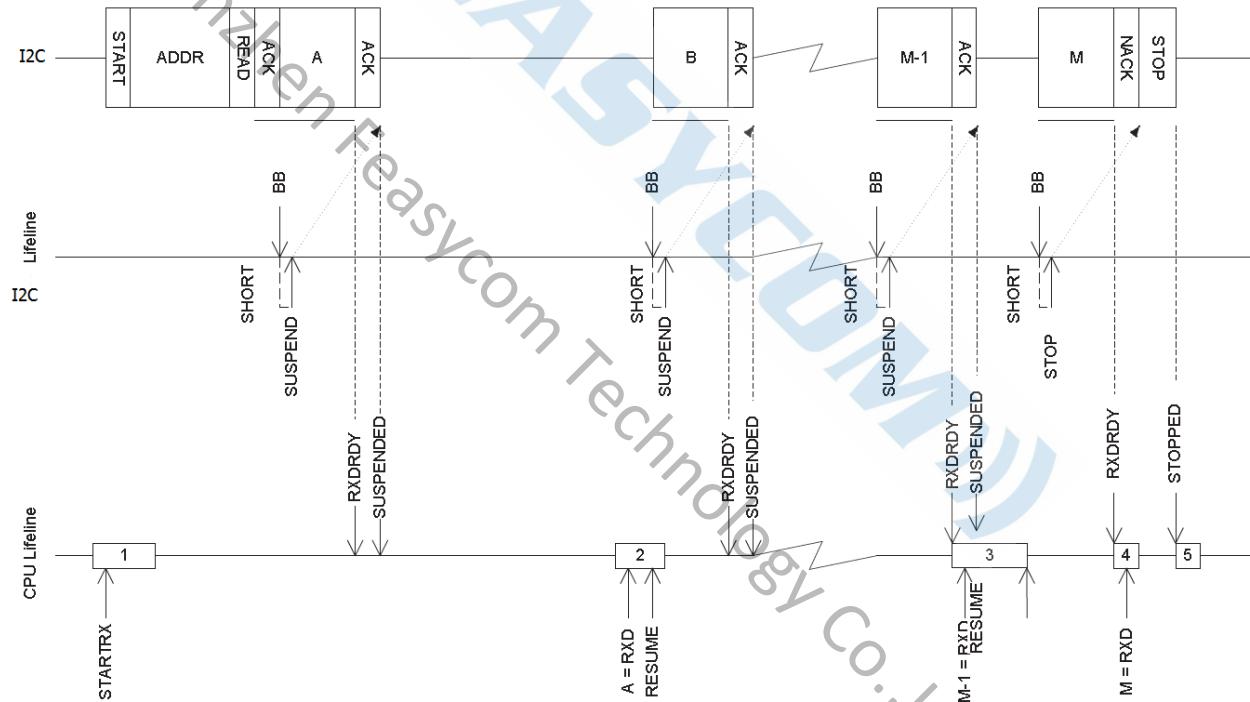
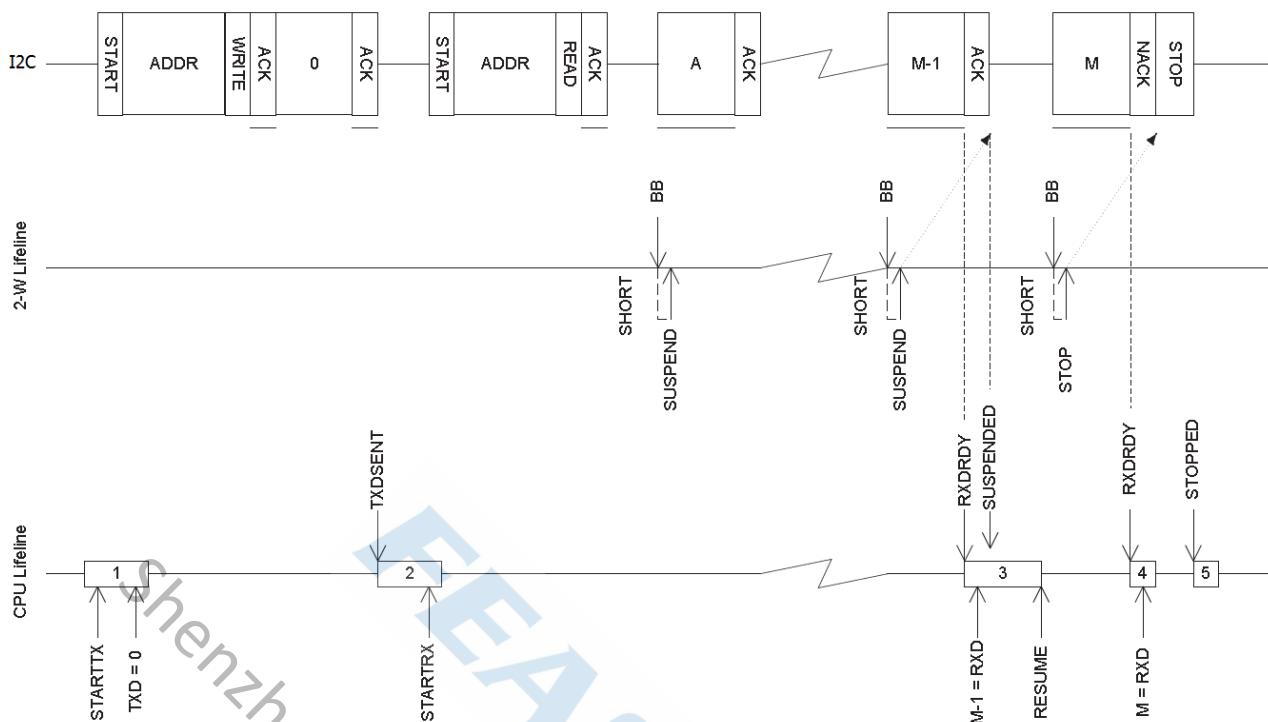


Figure 19: The I2C master reading data from a slave



**Figure 20:** A repeated start sequence, where the I2C master writes one byte, followed by reading M bytes from the slave without performing a stop in-between

## 4.9 Pulse width modulation (PWM)

The PWM module enables the generation of pulse width modulated signals on GPIO. The module implements an up or up-and-down counter with four PWM channels that drive assigned GPIOs.

Three PWM modules can provide up to 12 PWM channels with individual frequency control in groups of up to four channels. Furthermore, a built-in decoder and EasyDMA capabilities make it possible to manipulate the PWM duty cycles without CPU intervention. Arbitrary duty-cycle sequences are read from Data RAM and can be chained to implement ping-pong buffering or repeated into complex loops.

Listed here are the main features of one PWM module:

- Fixed PWM base frequency with programmable clock divider
- Up to four PWM channels with individual polarity and duty-cycle values
- Edge or center-aligned pulses across PWM channels
- Multiple duty-cycle arrays (sequences) defined in Data RAM
- Autonomous and glitch-free update of duty cycle values directly from memory through EasyDMA
- Change of polarity, duty-cycle, and base frequency possibly on every PWM period
- Data RAM sequences can be repeated or connected into loops

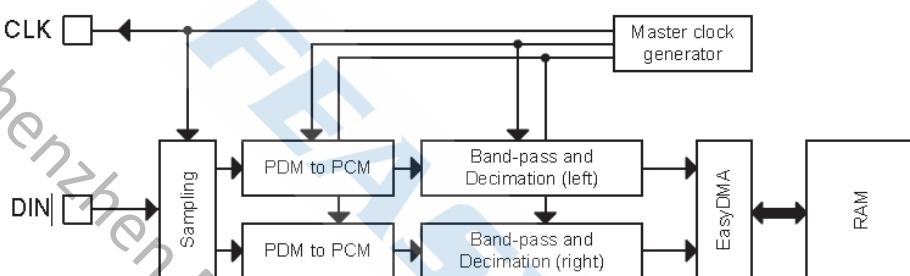
## 4.10 Pulse density modulation interface (PDM)

The pulse density modulation (PDM) module enables input of pulse density modulated signals from external audio frontends, for example, digital microphones. The PDM module generates the PDM clock and supports single-channel or dual-channel (Left and Right) data input. Data is transferred directly to RAM buffers using EasyDMA.

Listed here are the main features for PDM:

- Up to two PDM microphones configured as a Left/Right pair using the same data input
- 16 kHz output sample rate, 16-bit samples
- EasyDMA support for sample buffering
- HW decimation filters
- The PDM module illustrated

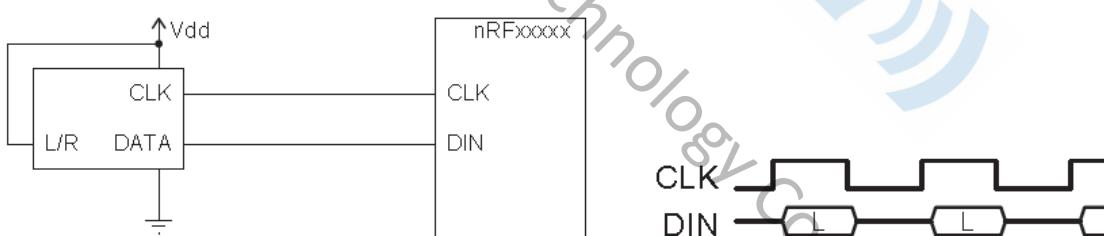
The PDM module illustrated is interfacing up to two digital microphones with the PDM interface. It implements EasyDMA, which relieves real-time requirements associated with controlling the PDM slave from a low priority CPU execution context. It also includes all the necessary digital filter elements to produce PCM samples. The PDM module allows continuous audio streaming.



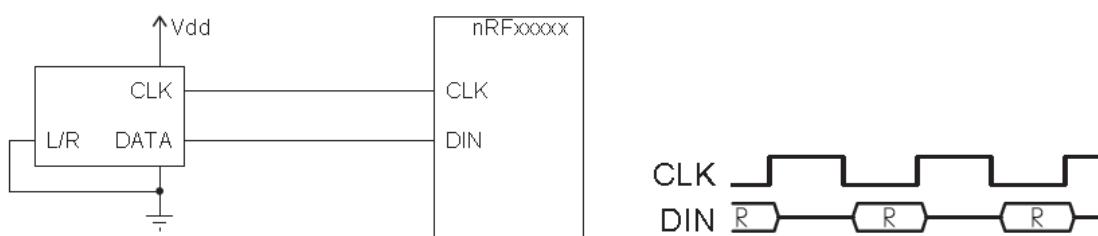
**Figure 21:** PDM module

#### 4.10.1 Hardware example

Connect the microphone clock to CLK, and data to DIN.

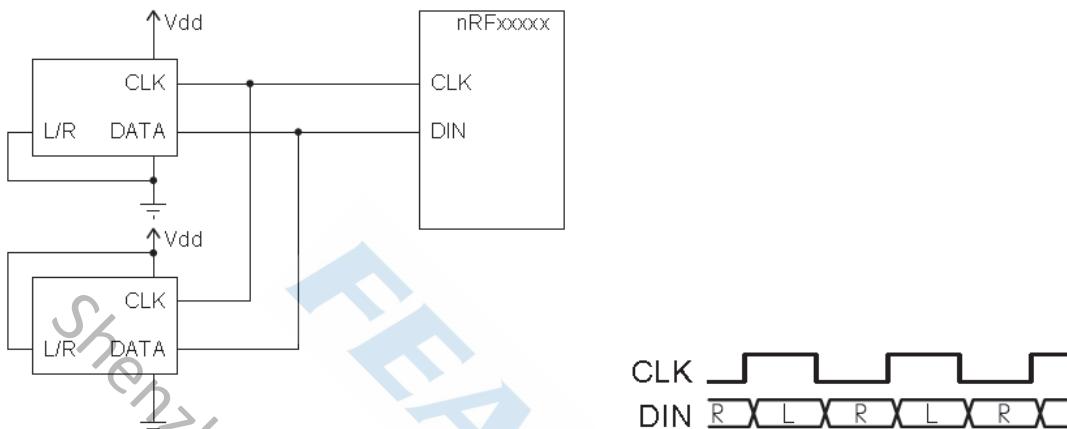


**Figure 22:** Example of a single PDM microphone, wired as left



**Figure 23:** Example of a single PDM microphone, wired as right

Note that in a single-microphone (mono) configuration, depending on the microphone's implementation, either the left or the right channel (sampled at falling or rising CLK edge respectively) will contain reliable data. If two microphones are used, one of them has to be set as left, the other as right (L/R pin tied high or to GND on the respective microphone). It is strongly recommended to use two microphones of exactly the same brand and type so that their timings in left and right operation match.



**Figure 24:** Example of two PDM microphones

## 4.11 Near field communication tag (NFC)

The NFC peripheral (referred to as the 'NFC peripheral' from now on) supports communication signal interface type A and 106 kbps bit rate from the NFC Forum.

With appropriate software, the NFC peripheral can be used to emulate the listening device NFC-A as specified by the NFC Forum.

Listed here are the main features for the NFC peripheral:

- NFC-A listen mode operation
  - 13.56 MHz input frequency
  - Bit rate 106 kbps
- Wake-on-field low power field detection (SENSE) mode
- Frame assemble and disassemble for the NFC-A frames specified by the NFC Forum
- Programmable frame timing controller
- Integrated automatic collision resolution, CRC and parity functions

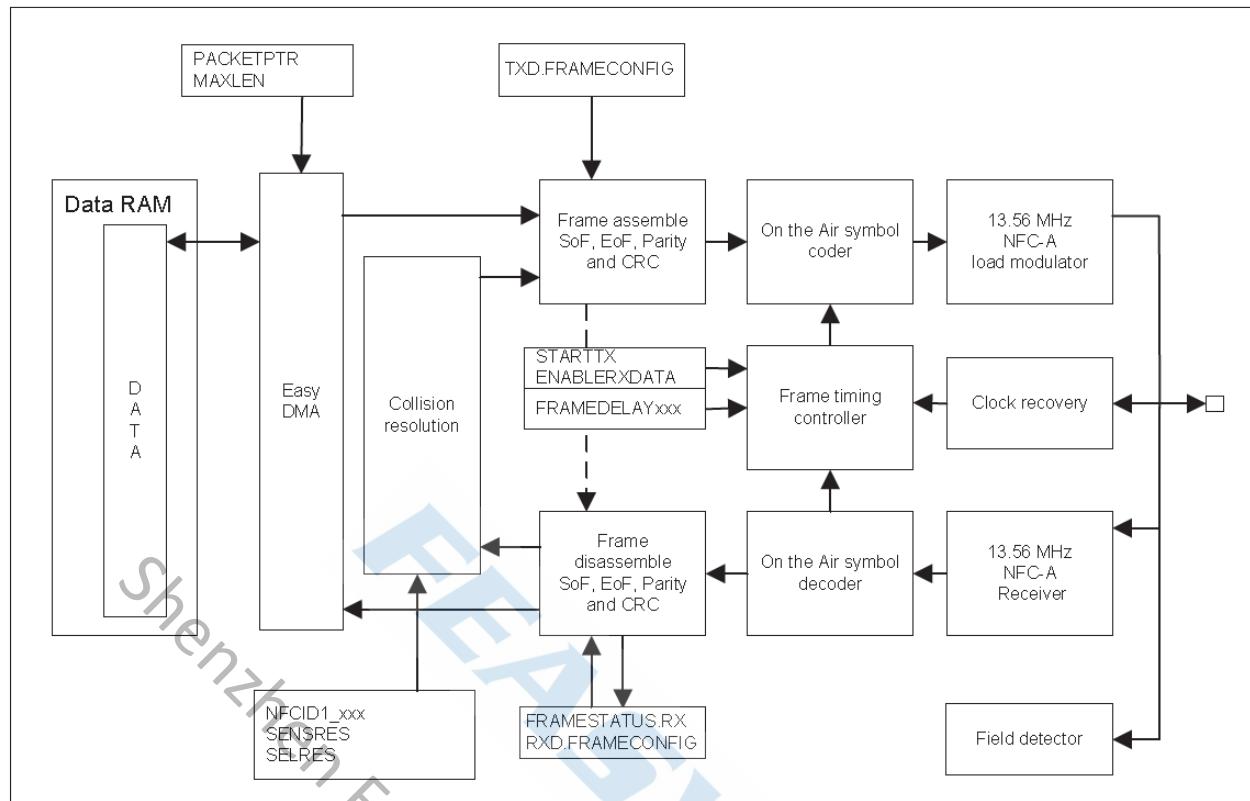


Figure 25: NFC block diagram

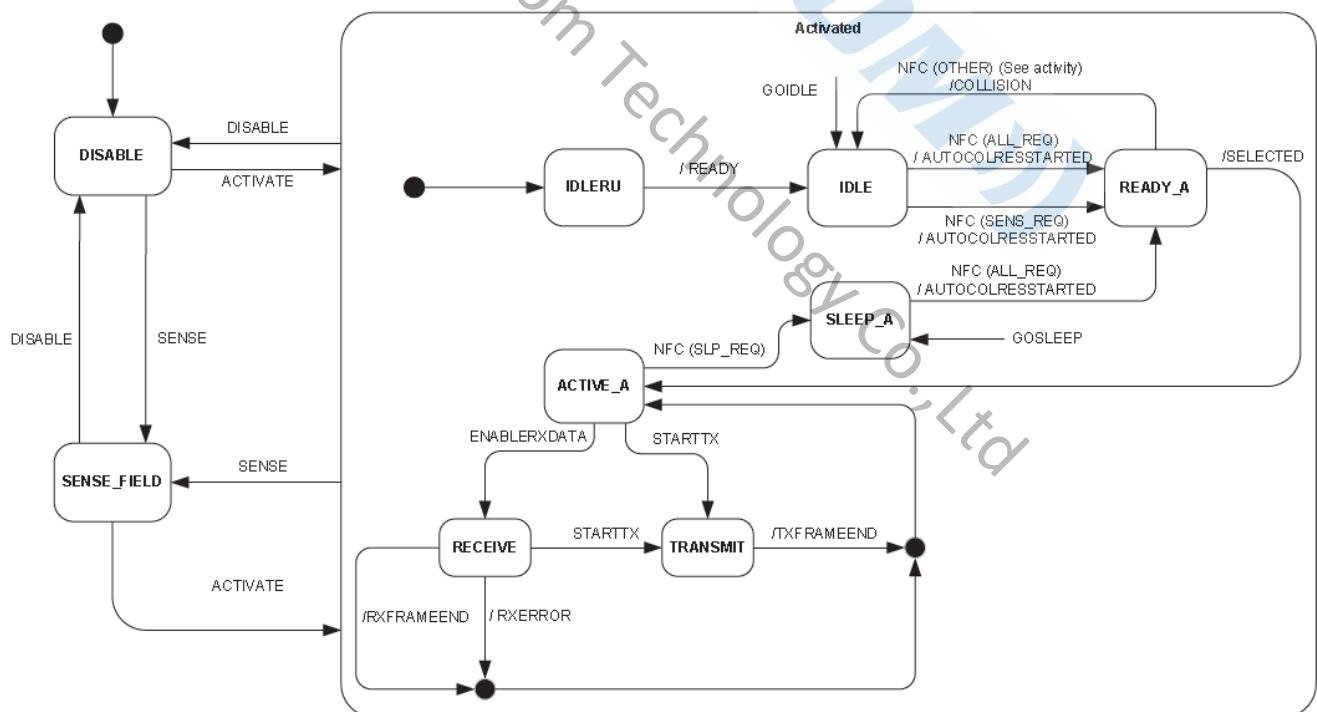


Figure 26: NFC state diagram

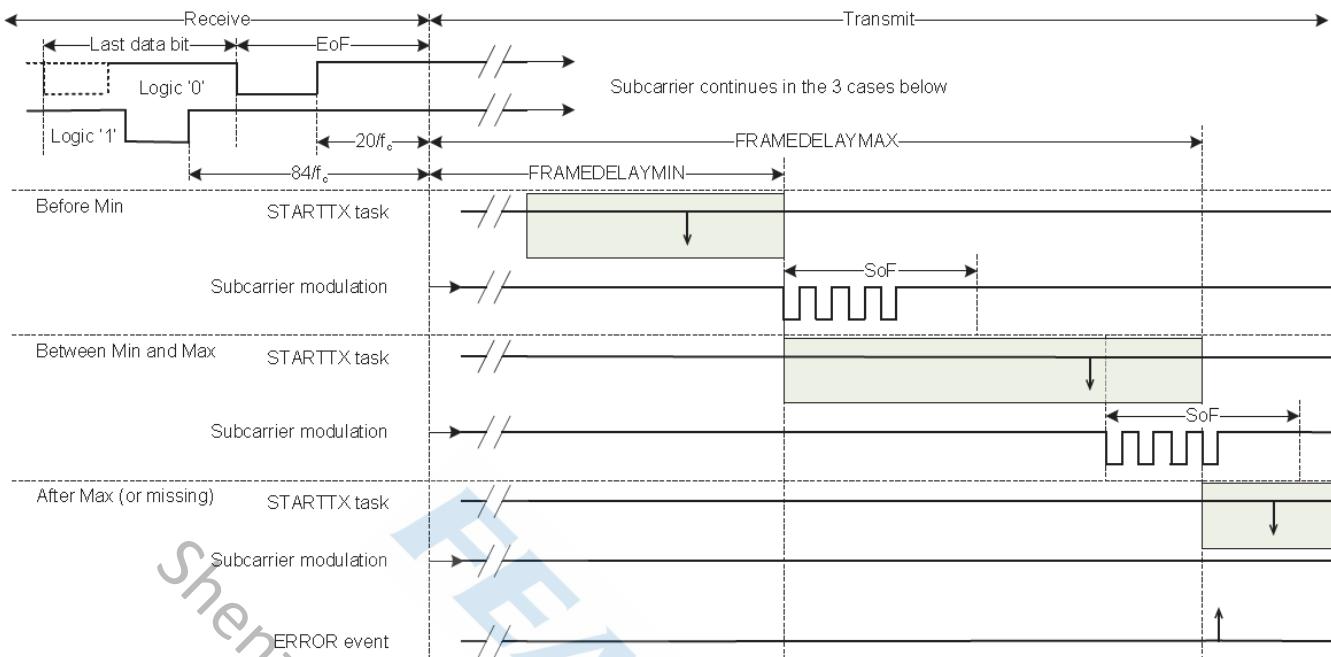


Figure 27: Frame timing controller (FRAMEDELAYMODE=Window)

#### 4.11.1 Antenna interface

In ACTIVATED state, an amplitude regulator will adjust the voltage swing on the antenna pins to a value that is within the  $V_{swing}$  limit.

#### 4.11.2 NFCT antenna recommendations

The NFCT antenna coil must be connected differential between NFC1 and NFC2 pins of the device.

Two external capacitors should be used to tune the resonance of the antenna circuit to 13.56MHz.

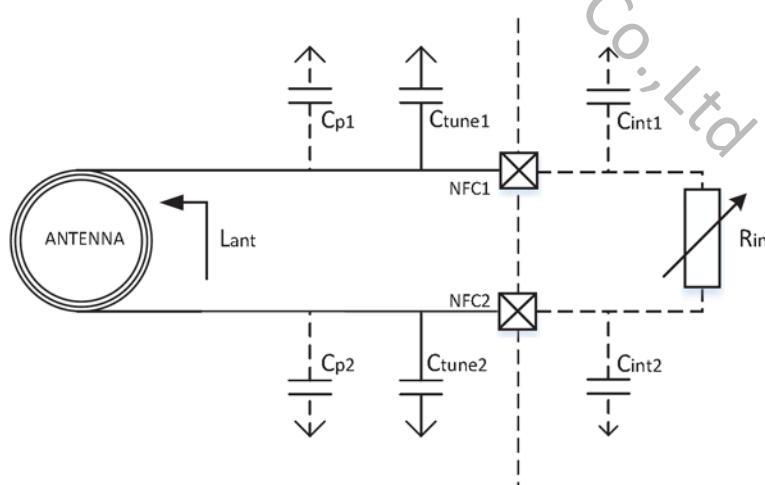


Figure 28: NFC antenna recommendations

The required tuning capacitor value is given by the below equations:

$$C_{tune} = \frac{1}{(2\pi \cdot 13.56 \text{ MHz})^2 \cdot L_{ant}} \quad \text{where } C_{tune} = \frac{1}{2} \cdot (C_p + C_{int} + C_{tune})$$

$$\text{and } C_{tunel} = C_{tune2} = C_{tune} \quad C_{p1} = C_{p2} = C_p \quad C_{int1} = C_{int2} = C_{int}$$

$$C_{tune} = \frac{2}{(2\pi \cdot 13.56 \text{ MHz})^2 \cdot L_{ant}} - C_p - C_{int}$$

An antenna inductance of  $L_{ant} = 2 \mu\text{H}$  will give tuning capacitors in the range of 130pF on each pin. For good performance, match the total capacitance on NFC1 and NFC2.

#### 4.11.3 Battery protection

If the antenna is exposed to a strong NFC field, current may flow in the opposite direction on the supply due to parasitic diodes and ESD structures.

If the battery used does not tolerate return current, a series diode must be placed between the battery and the device in order to protect the battery.

#### 4.11.4 References

NFC Forum, NFC Analog Specification version 1.0, [www.nfc-forum.org](http://www.nfc-forum.org)

NFC Forum, NFC Digital Protocol Technical Specification version 1.1, [www.nfc-forum.org](http://www.nfc-forum.org)

NFC Forum, NFC Activity Technical Specification version 1.1, [www.nfc-forum.org](http://www.nfc-forum.org)

## 5. ELECTRICAL CHARACTERISTICS

### 5.1 Absolute Maximum Ratings

Absolute maximum ratings for supply voltage and voltages on digital and analogue pins of the module are listed below. Exceeding these values causes permanent damage.

The average PIO pin output current is defined as the average current value flowing through any one of the corresponding pins for a 100mS period. The total average PIO pin output current is defined as the average current value flowing through all of the corresponding pins for a 100mS period. The maximum output current is defined as the value of the peak current flowing through any one of the corresponding pins.

**Table 5:** Absolute Maximum Rating

| Parameter                      | Min  | Max     | Unit |
|--------------------------------|------|---------|------|
| <b>Supply voltages</b>         |      |         |      |
| VDD                            | -0.3 | +3.9V   | V    |
| VSS                            | 0V   | V       |      |
| <b>I/O pin voltage</b>         |      |         |      |
| $V_{I/O}$ , VDD $\leq$ 3.6 V   | -0.3 | VDD+0.3 | V    |
| $V_{I/O}$ , VDD $>$ 3.6 V      | -0.3 | 3.9V    | V    |
| <b>NFC antenna pin current</b> |      |         |      |
| $I_{NFC1/2}$                   | 80   | mA      |      |
| <b>Radio</b>                   |      |         |      |
| RF input level                 | 10   | dBm     |      |
| <b>Environmental</b>           |      |         |      |
| Storage temperature            | -40  | +85     | °C   |

## 5.2 Recommended Operating Conditions

**Table 6:** Recommended Operating Conditions

| Parameter   | Min | Type | Max | Unit |
|---|-----|------|-----|------|
| $V_{DD}$ - Supply voltage, independent of DCDC enable | 1.7 | 3.0  | 3.6 | V    |
| $t_{R,VDD}$ - Supply rise time (0 V to 1.7 V)         |     |      | 60  | μS   |
| $T_A$ - Operating Temperature                         | -40 | 25   | +85 | °C   |

**Important:**

The on-chip power-on reset circuitry may not function properly for rise times longer than the specified maximum.

## 5.3 Input/output Terminal Characteristics

**Table 7:** GPIO Electrical Specification

| Parameter  | Min              | Type | Max              | Unit |
|--|------------------|------|------------------|------|
| $V_{IH}$ - Input High Voltage  | $0.7 \times VDD$ | -    | $VDD$            | V    |
| $V_{IL}$ - Input Low Voltage   | VSS              | -    | $0.3 \times VDD$ | V    |
| $V_{OH,HDH}$ - Output high voltage, standard drive, 0.5 mA, $VDD \geq 1.7$             | $VDD - 0.4$      | -    | $VDD$            | V    |
| $V_{OH,HDH}$ - Output high voltage, high drive, 5 mA, $VDD \geq 2.7$ V                 | $VDD - 0.4$      | -    | $VDD$            | V    |
| $V_{OH,HDL}$ - Output high voltage, high drive, 3 mA, $VDD \geq 1.7$ V                 | $VDD - 0.4$      | -    | $VDD$            | V    |
| $V_{OL,SD}$ - Output low voltage, standard drive, 0.5 mA, $VDD \geq 1.7$               | VSS              | -    | $VSS + 0.4$      | V    |
| $V_{OL,HDH}$ - Output low voltage, high drive, 5 mA, $VDD \geq 2.7$ V                  | VSS              | -    | $VSS + 0.4$      | V    |
| $V_{OL,HDL}$ - Output low voltage, high drive, 3 mA, $VDD \geq 1.7$ V                  | VSS              | -    | $VSS + 0.4$      | V    |
| $I_{OL,SD}$ - Current at $VSS + 0.4$ V, output set low, standard drive, $VDD \geq 1.7$ | 1                | 2    | 4                | mA   |
| $I_{OL,HDH}$ - Current at $VSS + 0.4$ V, output set low, high drive, $VDD \geq 2.7$ V  | 6                | 10   | 15               | mA   |

|                 |   |    |    |    |    |
|-----------------|---|----|----|----|----|
| $I_{OL,HDL}$    | - Current at VSS+0.4 V, output set low, high drive, VDD >= 1.7 V      | 3  | -  | -  | mA |
| $I_{OH,SD}$     | - Current at VDD-0.4 V, output set high, standard drive, VDD >= 1.7 V | 1  | 2  | 4  | mA |
| $I_{OH,HDH}$    | - Current at VDD-0.4 V, output set high, high drive, VDD >= 2.7 V     | 6  | 9  | 14 | mA |
| $I_{OH,HDL}$    | - Current at VDD-0.4 V, output set high, high drive, VDD >= 1.7 V     | 3  | -  | -  | mA |
| $t_{RF,15pF}$   | - Rise/fall time, low drive mode, 10-90%, 15 pF load1                 | -  | 9  | -  | nS |
| $t_{RF,25pF}$   | - Rise/fall time, low drive mode, 10-90%, 25 pF load1                 | -  | 13 | -  | nS |
| $t_{RF,50pF}$   | - Rise/fall time, low drive mode, 10-90%, 50 pF load1                 | -  | 25 | -  | nS |
| $t_{HRF,15pF}$  | - Rise/Fall time, high drive mode, 10-90%, 15 pF load1                | -  | 4  | -  | nS |
| $t_{HRF,25pF}$  | - Rise/Fall time, high drive mode, 10-90%, 25 pF load1                | -  | 5  | -  | nS |
| $t_{HRF,50pF}$  | - Rise/Fall time, high drive mode, 10-90%, 50 pF load1                | -  | 8  | -  | nS |
| $R_{PU}$        | - Pull-up resistance  | 11 | 13 | 16 | kΩ |
| $R_{PD}$        | - Pull-down resistance  | 11 | 13 | 16 | kΩ |
| $C_{PAD}$       | - Pad capacitance   | -  | 3  | -  | pF |
| $C_{PAD\_NFC}$  | - Pad capacitance on NFC pads   | -  | 4  | -  | pF |
| $I_{NFC\_LEAK}$ | - Leakage current between NFC pads when driven to different states    | -  | 2  | 10 | uA |

The current drawn from the battery when GPIO is active as an output is calculated as follows:

$$I_{GPIO} = V_{DD} C_{load} f$$

$C_{load}$  being the load capacitance and "f" is the switching frequency.

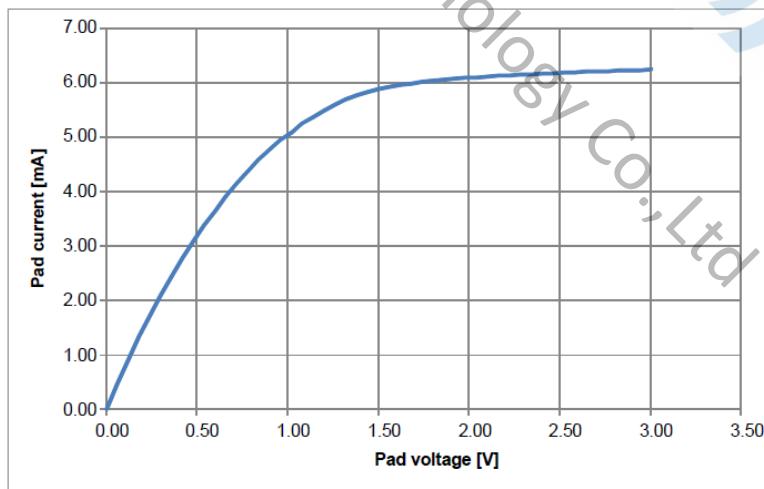
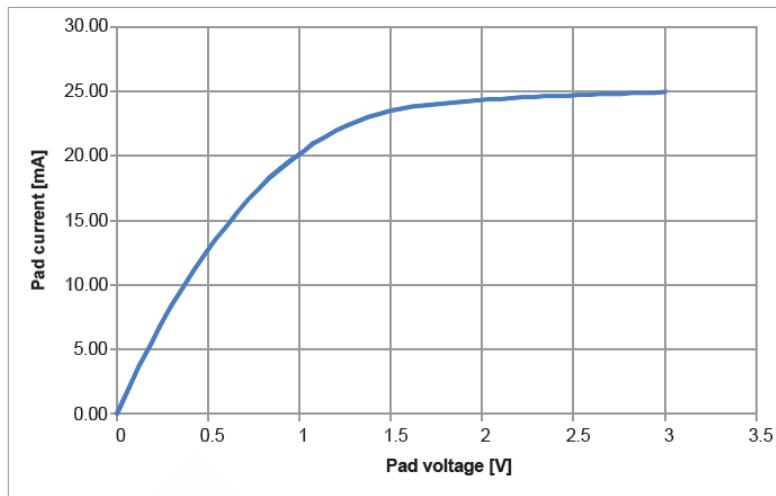
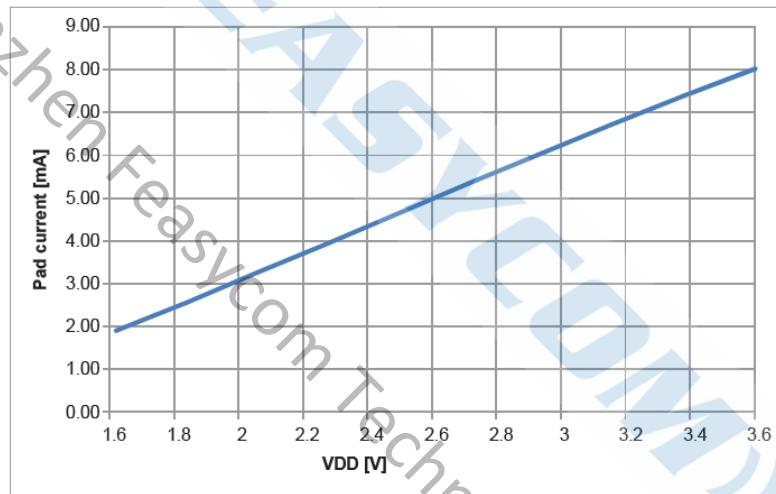


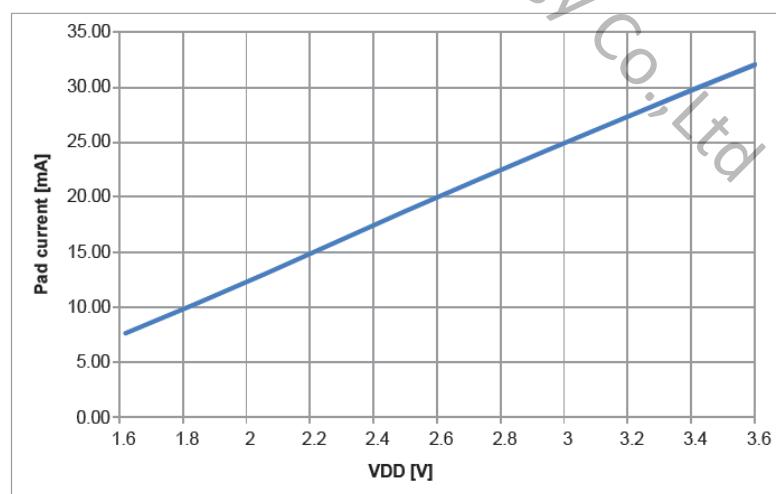
Figure 29: GPIO drive strength vs Voltage, standard drive, VDD = 3.0 V



**Figure 30:** GPIO drive strength vs Voltage, high drive, VDD = 3.0 V



**Figure 31:** Max sink current vs Voltage, standard drive



**Figure 32:** Max sink current vs Voltage, high drive

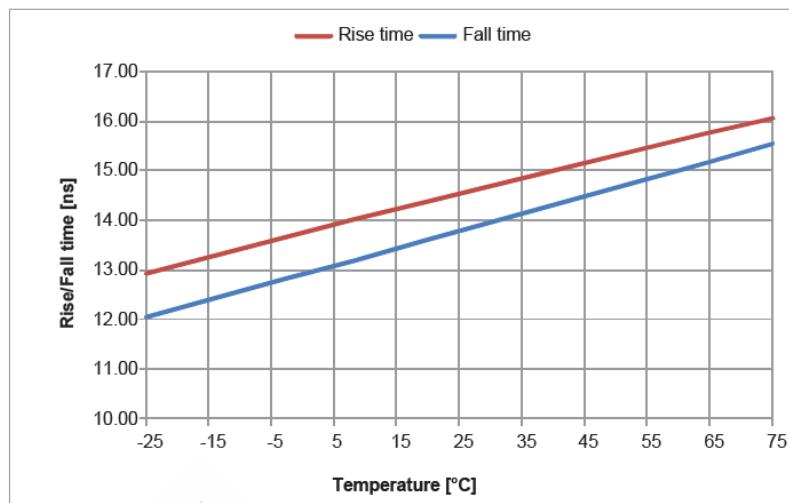


Figure 33: Rise and fall time vs Temperature, 10%-90%, 25pF load capacitance, VDD = 3.0 V

## 5.4 Analog Characteristics

### 5.4.1 ADC Electrical Specification

Table 8: ADC characteristics

| Parameter             |  | Min   | Typ  | Max | Unit |
|-----------------------|--|-------|------|-----|------|
| DNL                   | - Differential non-linearity, 10-bit resolution  | -0.95 | <1   | -   | LSB  |
| INL                   | - Integral non-linearity, 10-bit resolution  | -     | 1    | -   | LSB  |
| V <sub>OS</sub>       | - Differential offset error (calibrated), 10-bit resolution <sup>a</sup>                             | -     | +/-2 | -   | LSB  |
| C <sub>EG</sub>       | - Gain error temperature coefficient   | -     | 0.02 | -   | %/°C |
| f <sub>SAMPLE</sub>   | - Maximum sampling rate  | -     | -    | 200 | kHz  |
| t <sub>ACQ,10k</sub>  | - Acquisition time (configurable), source Resistance <= 10kOhm                                       | -     | 3    | -   | μs   |
| t <sub>ACQ,40k</sub>  | - Acquisition time (configurable), source Resistance <= 40kOhm                                       | -     | 5    | -   | μs   |
| t <sub>ACQ,100k</sub> | - Acquisition time (configurable), source Resistance <= 100kOhm                                      | -     | 10   | -   | μs   |
| t <sub>ACQ,200k</sub> | - Acquisition time (configurable), source Resistance <= 200kOhm                                      | -     | 15   | -   | μs   |
| t <sub>ACQ,400k</sub> | - Acquisition time (configurable), source Resistance <= 400kOhm                                      | -     | 20   | -   | μs   |
| t <sub>ACQ,800k</sub> | - Acquisition time (configurable), source Resistance <= 800kOhm                                      | -     | 40   | -   | μs   |
| t <sub>CONV</sub>     | - Conversion time  | -     | <2   | -   | μs   |
| I <sub>ADC,CONV</sub> | - ADC current during ACQuisition and CONVersion  | -     | 700  | -   | μA   |
| I <sub>ADC,IDL</sub>  | - Idle current, when not sampling, excluding clock sources and regulator base currents <sup>33</sup> | -     | <5   | -   | μA   |
| E <sub>G1/6</sub>     | - Errorb for Gain = 1/6  | -3    | -    | 3   | %    |
| E <sub>G1/4</sub>     | - Errorb for Gain = 1/4  | -3    | -    | 3   | %    |
| E <sub>G1/2</sub>     | - Errorb for Gain = 1/2  | -3    | -    | 4   | %    |
| E <sub>G1</sub>       | - Errorb for Gain = 1  | -3    | -    | 4   | %    |
| C <sub>SAMPLE</sub>   | - Sample and hold capacitance at maximum gain  | -     | 2.5  | -   | pF   |
| R <sub>INPUT</sub>    | - Input resistance   | -     | >1   | -   | MΩ   |
| E <sub>NOB</sub>      | - Effective number of bits, differential mode, 12-bit resolution,                                    | -     | 9    | -   | Bit  |

1/1 gain, 3  $\mu$ s acquisition time, crystal HFCLK, 200 kspS

|  |   |     |   |            |
|--|---|-----|---|------------|
| S <sub>NDR</sub> - Peak signal to noise and distortion ratio, differential mode, 12-bit resolution, 1/1 gain, 3 $\mu$ s acquisition time, crystal HFCLK, 200kspS | - | 56  | - | dB         |
| S <sub>FDR</sub> - Spurious free dynamic range, differential mode, 12-bit resolution, 1/1 gain, 3 $\mu$ s acquisition time, crystal HFCLK, 200kspS               | - | 70  | - | dBc        |
| R <sub>LADDER</sub> - Ladder resistance  | - | 160 | - | k $\Omega$ |

a :Digital output code at zero volt differential input.

33 :When t<sub>ACQ</sub> is 10us or longer, and if DC/DC is active, it will be allowed to work in refresh mode if no other resource is requiring a high quality power supply from 1V3. If t<sub>ACQ</sub> is smaller than 10us and DC/DC is active,

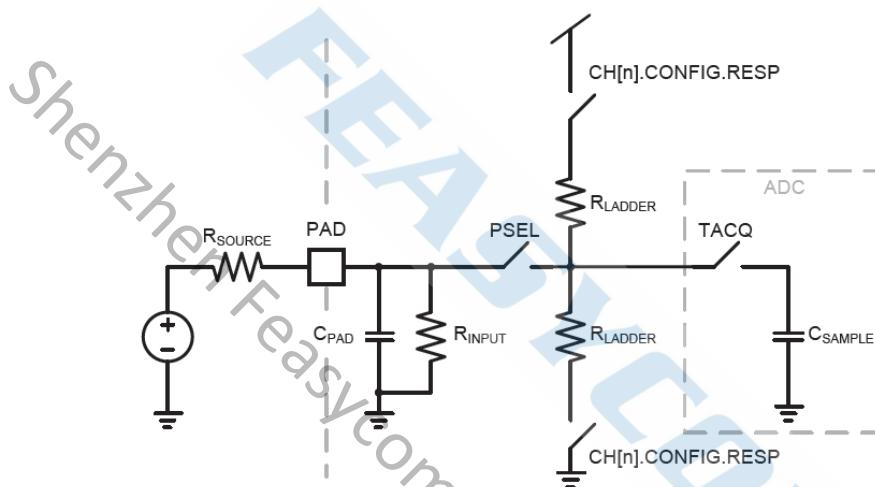


Figure 34: Model of SAADC input (one channel)

**Note:** SAADC average current calculation for a given application is based on the sample period, conversion and acquisition time ( t<sub>CONV</sub> and t<sub>ACQ</sub> ) and conversion and idle current ( I<sub>ADC,CONV</sub> and I<sub>ADC,IDLE</sub> ). For example,sampling at 4kHz gives a sample period of 250 $\mu$ s. The average current consumption would then be:

$$I_{AVERAGE} = \left( \frac{(t_{CONV} + t_{ACQ})}{250} \right) (I_{ADC,CONV}) + \left( \frac{250 - (t_{CONV} + t_{ACQ})}{250} \right) (I_{ADC,IDLE})$$

Figure 35: Typical connection diagram using the ADC

## 5.5 SPI Electrical specification

### 5.5.1 SPI master interface

**Table 9:** SPI master interface electrical specifications

| Parameter  |  | Min | Typ                     | Max            | Unit    |
|--|--|-----|-------------------------|----------------|---------|
| $f_{SPI}$ - Bit rates for SPI <sup>a</sup>   |  | -   | -                       | 8 <sup>b</sup> | Mbps    |
| $I_{SPI,2Mbps}$ - Run current for SPI, 2 Mbps  |  | -   | -                       | 50             | $\mu A$ |
| $I_{SPI,8Mbps}$ - Run current for SPI, 8 Mbps  |  | -   | -                       | 50             | $\mu A$ |
| $I_{SPI,IDL}$ - current for SPI (STARTed, no CSN activity)   |  | -   | <1                      | -              | $\mu A$ |
| $t_{SPI,START,LP}$ - Time from writing TXD register to transmission started, low power mode        |  | -   | +<br>$t_{SPI,START,CL}$ | -              | $\mu s$ |
| $t_{SPI,START,CL}$ - Time from writing TXD register to transmission started, constant latency mode |  | -   | 1<br>$t_{START\_HFINT}$ | -              | $\mu s$ |

a:Higher bit rates may require GPIOs to be set as High Drive, see GPIO chapter for more details.

b:The actual maximum data rate depends on the slave's CLK to MISO and MOSI setup and hold timings.

**Table 10:** Serial Peripheral Interface (SPI) Master timing specifications

| Parameter  |  | Min                    | Typ | Max            | Unit |
|--|--|------------------------|-----|----------------|------|
| $t_{SPI,CSC,8Mbps}$ - SCK period at 8Mbps                  |  | -                      | 125 | -              | nS   |
| $t_{SPI,CSC,4Mbps}$ - SCK period at 4Mbps                  |  | -                      | 250 | -              | nS   |
| $t_{SPI,CSC,2Mbps}$ - SCK period at 2Mbps                  |  | -                      | 500 | -              | nS   |
| $t_{SPI,RSCK,LD}$ - SCK rise time, low drive <sup>a</sup>  |  | -                      | -   | $t_{RF,25pF}$  |      |
| $t_{SPI,RSCK,HD}$ - SCK rise time, high drive <sup>a</sup> |  | -                      | -   | $t_{HRF,25pF}$ |      |
| $t_{SPI,FSCK,LD}$ - SCK fall time, low drive <sup>a</sup>  |  | -                      | -   | $t_{RF,25pF}$  |      |
| $t_{SPI,FSCK,HD}$ - SCK fall time, high drive <sup>a</sup> |  | -                      | -   | $t_{HRF,25pF}$ |      |
| $t_{SPI,WHSCK}$ - SCK high time <sup>a</sup>               |  | (0.5*tCSCK)<br>- tRSCK |     |                |      |
| $t_{SPI,WLSCK}$ - SCK low time <sup>a</sup>                |  | (0.5*tCSCK)<br>- tFSCK |     |                |      |
| $t_{SPI,SUMI}$ - MISO to CLK edge setup time               |  | 19                     |     |                | ns   |
| $t_{SPI,HMI}$ - CLK edge to MISO hold time                 |  | 18                     |     |                | ns   |
| $t_{SPI,VMO}$ - CLK edge to MOSI valid                     |  |                        |     | 59             | ns   |
| $t_{SPI,HMO}$ - MOSI hold time after CLK edge              |  | 20                     |     |                | ns   |

a: At 25pF load, including GPIO capacitance, see GPIO spec.

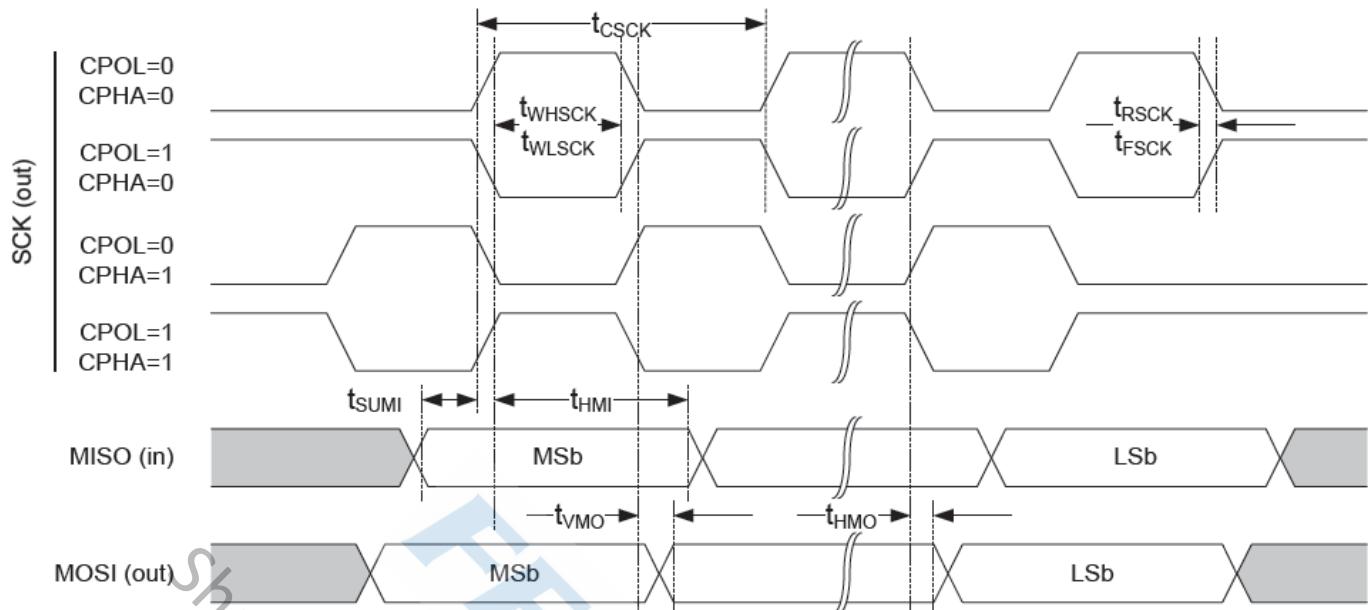


Figure 36: SPI master timing diagram

### 5.5.2 SPI slave interface electrical specifications

Table 11: SPI slave interface electrical specifications

| Parameter  |  | Min | Typ  | Max            | Unit    |
|--|--|-----|--|----------------|---------|
| $f_{SPI}$ - Bit rates for SPI <sup>a</sup>   |  | -   | -  | 8 <sup>b</sup> | Mbps    |
| $I_{SPI,2Mbps}$ - Run current for SPI, 2 Mbps  |  | -   | 45   | -              | $\mu A$ |
| $I_{SPI,8Mbps}$ - Run current for SPI, 8 Mbps  |  | -   | 45   | -              | $\mu A$ |
| $I_{SPI,IDLE}$ - current for SPI (STARTed, no CSN activity)  |  | -   | 1  | -              | $\mu A$ |
| $t_{SPI,L_P,START}$ - Time from RELEASE task to ready to receive/transmit (CSN active), Low power mode |  | -   | $t_{SPI,CL,START}$<br>$+ t_{START\_HFINT}$ | -              | $\mu s$ |
| $t_{SPI,CL,START}$ - Time from RELEASE task to receive/transmit (CSN active), Constant latency mode    |  | -   | 0.125                                      | -              | $\mu s$ |

a:Higher bit rates may require GPIOs to be set as High Drive, see GPIO chapter for more details.

b:The actual maximum data rate depends on the slave's CLK to MISO and MOSI setup and hold timings.

Table 12: Serial Peripheral Interface Slave (SPIS) timing specifications

| Parameter                                   |  | Min | Typ | Max | Unit |
|---|--|-----|-----|-----|------|
| $t_{SPI,CSCK,8Mbps}$ - SCK period at 8Mbps  |  | -   | 125 | -   | nS   |
| $t_{SPI,CSCK,4Mbps}$ - SCK period at 4Mbps  |  | -   | 250 | -   | nS   |
| $t_{SPI,CSCK,2Mbps}$ - SCK period at 2Mbps  |  | -   | 500 | -   | nS   |
| $t_{SPI,RFSCIN}$ - SCK input rise/fall time |  |     |     | 30  | nS   |
| $t_{SPI,WHSCKIN}$ - SCK input high time     |  |     |     | 30  | nS   |

|  |                          |    |
|--|--------------------------|----|
| $t_{SPIS,WLSCKIN}$ - SCK input low time                            | 30                       | nS |
| $t_{SPIS,SUCSN,LP}$ - CSN to CLK setup time, Low power mode        | $t_{SPIS,SUCSN,CL}$<br>+ | nS |
|  | $t_{START\_HFINT}$       |    |
| $t_{SPIS,SUCSN,CL}$ - CSN to CLK setup time, Constant latency mode | 1000                     | nS |
| $t_{SPIS,HCSN}$ - CLK to CSN hold time                             | 2000                     | nS |
| $t_{SPIS,ASO}$ - CSN to MISO driven <sup>a</sup>                   | 1000                     | nS |
| $t_{SPIS,DISSO}$ - CSN to MISO disabled <sup>a</sup>               | 68                       | nS |
| $t_{SPIS,CWH}$ - CSN inactive time                                 | 300                      | nS |
| $t_{SPIS,VSO}$ - CLK edge to MISO valid                            | 19                       | nS |
| $t_{SPIS,HSO}$ - MISO hold time after CLK edge                     | 18 <sup>b</sup>          | nS |
| $t_{SPIS,SUSI}$ - MOSI to CLK edge setup time                      | 59                       | nS |
| $t_{SPIS,HSI}$ - CLK edge to MOSI hold time                        | 20                       | nS |

a: At 25pF load, including GPIO capacitance, see GPIO spec.

b: This is to ensure compatibility to SPI masters sampling MISO on the same edge as MOSI is output

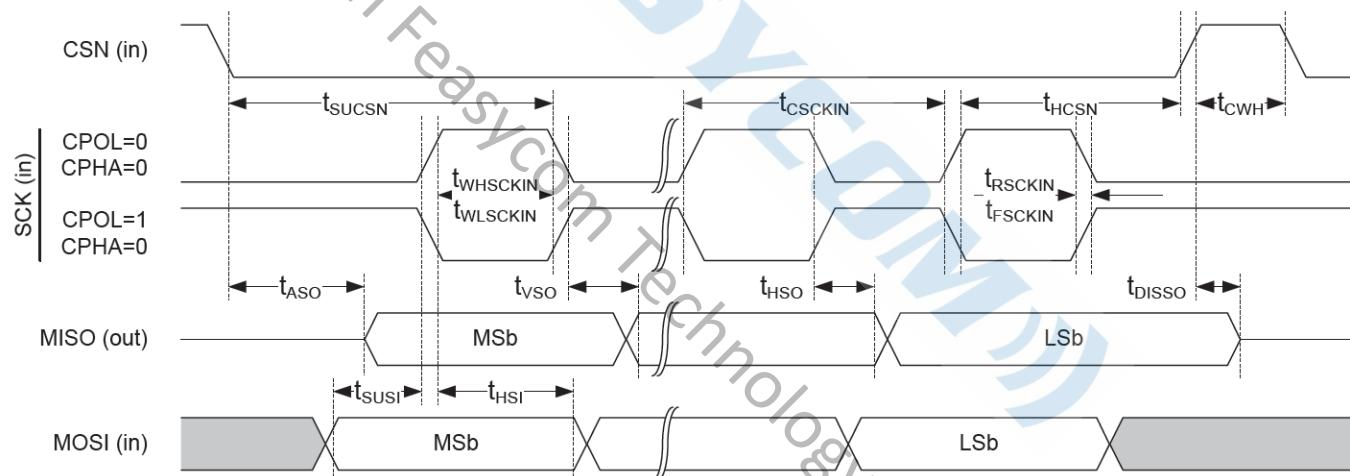


Figure 37: SPI timing diagram(Slave)

## 5.6 I2C Dynamic Characteristics

### 5.6.1 I2C Master interface electrical specifications

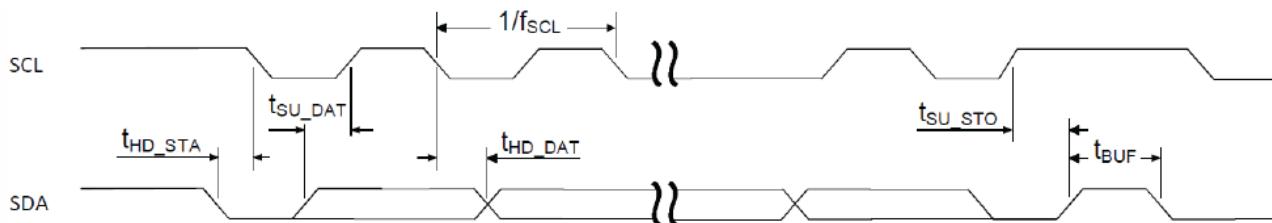
Table 13: I2C interface electrical specifications(Master)

| Parameter   | Min | Typ                     | Max | Unit    |
|---|-----|-------------------------|-----|---------|
| $f_{I2C}$ - Bit rates for I2C <sup>a</sup>  | 100 | -                       | 400 | Kbps    |
| $I_{I2C,100kbpss}$ - Run current for I2C, 100 kbps  | -   | 50                      | -   | $\mu A$ |
| $I_{I2C,400kbpss}$ - Run current for I2C, 400 kbps  | -   | 50                      | -   | $\mu A$ |
| $t_{I2C,START,LP}$ - Time from STARTRX/STARTTX task to transmission started, Low power mode | -   | $T_{I2C,START,CL}$<br>+ | -   | $\mu S$ |

|  | $t_{START\_HFINT}$ |     |         |
|--|--------------------|-----|---------|
| $t_{I2C,START,CL}$ - Time from STARTRX/STARTTX task to transmission started,<br>Constant latency mode                  | -                  | 1.5 | $\mu$ S |
| a: Higher bit rates or stronger pull-ups may require GPIOs to be set as High Drive, see GPIO chapter for more details. |                    |     |         |

**Table 14:** Two Wire Interface (I2C) timing specifications(Master)

| Parameter  | Min   | Typ | Max | Unit |
|--|-------|-----|-----|------|
| $f_{I2C,SCL,100kbps}$ - SCL clock frequency, 100 kbps  | -     | 100 | -   | KHz  |
| $f_{I2C,SCL,250kbps}$ - SCL clock frequency, 250 kbps  | -     | 250 | -   | KHz  |
| $f_{I2C,SCL,400kbps}$ - SCL clock frequency, 400 kbps  | -     | 400 | -   | KHz  |
| $t_{I2C,SU,DAT}$ - Data setup time before positive edge on SCL – all modes                       | 300   | -   | -   | nS   |
| $t_{I2C,HD,DAT}$ - Data hold time after negative edge on SCL – all modes                         | 500   | -   | -   | nS   |
| $t_{I2C,HD,STA,100kbps}$ - I2C master hold time for START and repeated START condition, 100 kbps | 10000 | -   | -   | nS   |
| $t_{I2C,HD,STA,250kbps}$ - I2C master hold time for START and repeated START condition, 250kbps  | 4000  | -   | -   | nS   |
| $t_{I2C,HD,STA,400kbps}$ - I2C master hold time for START and repeated START condition,400 kbps  | 2500  | -   | -   | nS   |
| $t_{I2C,SU,STO,100kbps}$ - I2C master setup time from SCL high to STOP condition, 100kbps        | 5000  | -   | -   | nS   |
| $t_{I2C,SU,STO,250kbps}$ - I2C master setup time from SCL high to STOP condition, 250kbps        | 2000  | -   | -   | nS   |
| $t_{I2C,SU,STO,400kbps}$ - I2C master setup time from SCL high to STOP condition, 400kbps        | 1250  | -   | -   | nS   |
| $t_{I2C,BUF,100kbps}$ - I2C master bus free time between STOP and START conditions,100 kbps      | 5800  | -   | -   | nS   |
| $t_{I2C,BUF,250kbps}$ - I2C master bus free time between STOP and START conditions,250 kbps      | 2700  | -   | -   | nS   |
| $t_{I2C,BUF,400kbps}$ - I2C master bus free time between STOP and START conditions,400 kbps      | 2100  | -   | -   | nS   |

**Figure 38:** I2C timing diagram, 1 byte transaction

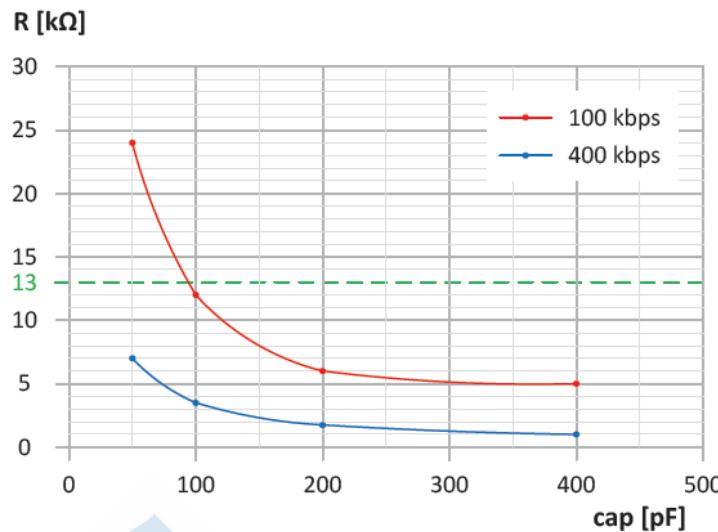


Figure 39: Recommended TWIM pullup value vs. line capacitance

- The I2C specification allows a line capacitance of 400 pF at most.
- FSC-BT630 internal pullup has a fixed value of typ. 13 kOhm, see RPU in the GPIO chapter.

### 5.6.2 I2C slave interface electrical specifications

Table 15: I2C interface electrical specifications(Slave)

| Parameter   | Min  | Typ | Max | Unit |
|---|--|-----|-----|------|
| f <sub>I2C</sub> - Bit rates for I2C <sup>a</sup>   | 100  | -   | 400 | Kbps |
| I <sub>I2C,100kbps</sub> - Run current for I2C, 100 kbps  | -  | 45  | -   | µA   |
| I <sub>I2C,400kbps</sub> - Run current for I2C, 400 kbps  | -  | 45  | -   | µA   |
| I <sub>I2C,IDLE</sub> - Idle current for I2C  | -  | 1   | -   | uA   |
| t <sub>I2C,START,LP</sub> - Time from PREPARERX/PREPARETX task to transmission started, Low power mode        | T <sub>I2C,START,CL</sub><br>+<br>t <sub>START_HFINT</sub> | -   | -   | µS   |
| t <sub>I2C,START,CL</sub> - Time from PREPARERX/PREPARETX task to transmission started, Constant latency mode |  | 1.5 | -   | µS   |

a: Higher bit rates or stronger pull-ups may require GPIOs to be set as High Drive, see GPIO chapter for more details.

Table 16: Two Wire Interface (I2C) timing specifications(Master)

| Parameter  | Min  | Typ | Max | Unit |
|--|------|-----|-----|------|
| f <sub>I2C,SCL,400kbps</sub> - SCL clock frequency, 400 kbps                                   | -    | 400 | -   | KHz  |
| t <sub>I2C,SU_DAT</sub> - Data setup time before positive edge on SCL – all modes              | 300  | -   | -   | nS   |
| t <sub>I2C,HD_DAT</sub> - Data hold time after negative edge on SCL – all modes                | 500  | -   | -   | nS   |
| t <sub>I2C,HD_STA,100kbps</sub> - I2C slave hold time from for START condition (SDA low to SCL | 5200 | -   | -   | nS   |

|   |      |      |   |   |    |
|---|------|------|---|---|----|
| low), 100 kbps  |      |      |   |   |    |
| $t_{I2C,HD\_STA,400kbps}$ - I2C slave hold time from for START condition (SDA low to SCL low), 400 kbps | 1300 | -    | - | - | nS |
| $t_{I2C,SU\_STO,100kbps}$ - I2C slave setup time from SCL high to STOP condition, 100 kbps              | 5200 | -    | - | - | nS |
| $t_{I2C,SU\_STO,400kbps}$ - I2C slave setup time from SCL high to STOP condition, 400 kbps              | 1300 | -    | - | - | nS |
| $t_{I2C,BUF,100kbps}$ - I2C slave bus free time between STOP and START conditions, 100 kbps             | -    | 4700 | - | - | nS |
| $t_{I2C,BUF,400kbps}$ - I2C slave bus free time between STOP and START conditions, 400 kbps             | -    | 1300 | - | - | nS |

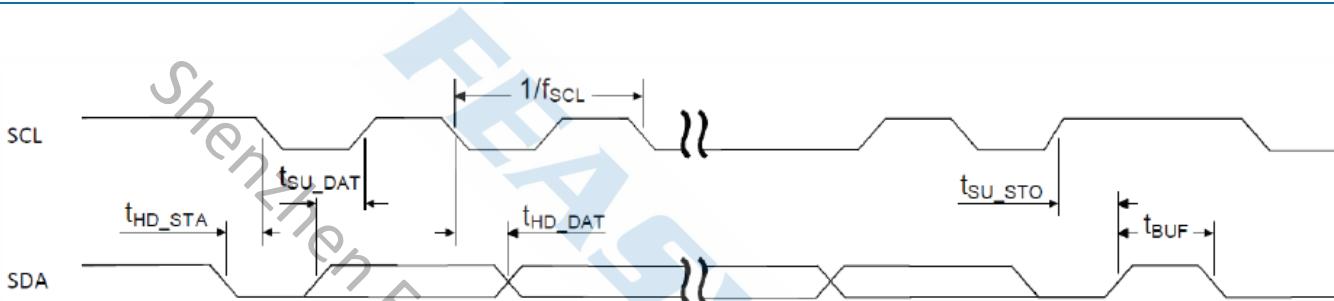


Figure 40: I2C timing diagram, 1 byte transaction

## 5.7 I2S Electrical specification

Table 17: I2S Dynamic Characteristics

| Parameter  |    | Min | Typ  | Max | Unit |
|--|----|-----|------|-----|------|
| $t_{S\_SDIN}$ - SDIN setup time before SCK rising    | 20 | -   | 400  | 400 | nS   |
| $t_{H\_SDIN}$ - SDIN hold time after SCK rising      | 15 | 50  | -    | -   | nS   |
| $t_{S\_SDOUT}$ - SDOUT setup time after SCK falling  | 40 | 50  | -    | -   | nS   |
| $t_{H\_SDOUT}$ - SDOUT hold time before SCK falling  | 6  | -   | -    | -   | nS   |
| $t_{SCK\_LRCK}$ - SCLK falling to LRCK edge          | -5 | 0   | 5    | nS  |      |
| $f_{MCK}$ - MCK frequency                            | -  | -   | 4000 | KHz |      |
| $f_{LRCK}$ - LRCK frequency                          | -  | -   | 48   | KHz |      |
| $f_{SCK}$ - SCK frequency                            | -  | -   | 2000 | KHz |      |
| DC <sub>CK</sub> - Clock duty cycle (MCK, LRCK, SCK) | 45 | -   | 55   | %   |      |

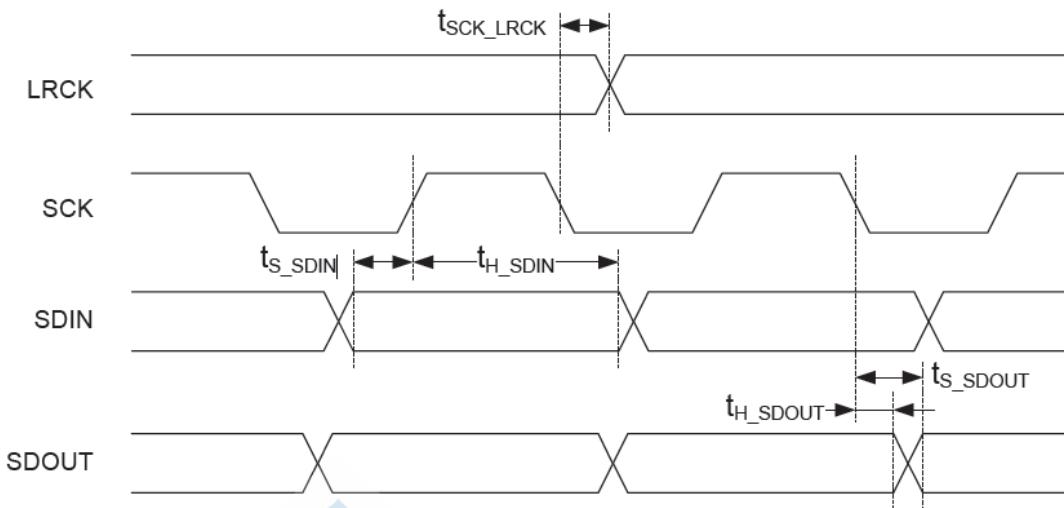


Figure 41: I2S timing diagram

## 5.8 PWM Characteristics

Table 18: PWM Electrical Specification

| Parameter  |  | Min | Typ | Max | Unit |
|--|--|-----|-----|-----|------|
| $I_{PWM,16MHz}$ - PWM run current, Prescaler set to DIV_1 (16 MHz), excluding DMA and GPIO     |  | -   | 200 | -   | uA   |
| $I_{PWM,8MHz}$ - PWM run current, Prescaler set to DIV_2 (8 MHz), excluding DMA and GPIO       |  | -   | 150 | -   | uA   |
| $I_{PWM,125kHz}$ - PWM run current, Prescaler set to DIV_128 (125 kHz), excluding DMA and GPIO |  | -   | 150 | -   | uA   |

## 5.9 PDM Characteristics

Table 19: PDM Electrical Specification

| Parameter   |    | Min | Typ   | Max | Unit |
|---|----|-----|-------|-----|------|
| $I_{PDM,stereo}$ - PDM module active current, stereo operation <sup>a</sup> |    | -   | 1.4   | -   | mA   |
| $f_{PDM,CLK}$ - PDM clock speed   |    | -   | 1.032 | -   | MHz  |
| $t_{PDM,JITTER}$ - Jitter in PDM clock output                               |    | -   | -     | 20  | nS   |
| $T_{dPDM,CLK}$ - PDM clock duty cycle                                       | 40 | 50  | 60    | %   |      |
| $t_{PDM,DATA}$ - Decimation filter delay                                    | -  | -   | 5     | ms  |      |
| $t_{PDM,cv}$ - Allowed clock edge to data valid                             | -  | -   | 125   | nS  |      |
| $t_{PDM,ci}$ - Allowed (other) clock edge to data invalid                   | 0  | -   | -     | nS  |      |
| $t_{PDM,s}$ - Data setup time at $f_{PDM,CLK}=1.024$ MHz                    | 65 | -   | -     | nS  |      |
| $t_{PDM,h}$ - Data hold time at $f_{PDM,CLK}=1.024$ MHz                     | 0  | -   | -     | nS  |      |
| $G_{PDM,default}$ - Default (reset) absolute gain of the PDM module         | -  | 3.2 | -     | dB  |      |

a: Average current including PDM and DMA transfers, excluding clock and power supply base currents

## 5.10 UART Electrical Specification

Table 20: UART Electrical Specification

| Parameter        |  | Min | Typ                         | Max              | Unit |
|------------------|--|-----|-----------------------------|------------------|------|
| fUART -          | Baud rate for UART <sup>a</sup>  | -   | -                           | 1000             | Kbps |
| IUART1M -        | Run current at max baud rate.  | -   | 55                          | -                | uA   |
| IUART115k -      | Run current at 115200 bps.   | -   | 55                          | -                | uA   |
| IUART1k2 -       | Run current at 1200 bps.   | -   | 55                          | -                | uA   |
| IUART,IDL        | Idle current for UART  | -   | 1                           | -                | uA   |
| tUART,CTS        | CTS high time  | 1   | -                           | -                | uS   |
| tUART,START,LP - | Time from STARTRX/STARTTX task to transmission started,<br>low power mode        | -   | +<br><br>$t_{START\_HFINT}$ | $t_{UART,START}$ | uS   |
| tUART,START,CL - | Time from STARTRX/STARTTX task to transmission started,<br>constant latency mode | -   | 1                           | -                | uS   |

a: Higher baud rates may require GPIOs to be set as High Drive, see GPIO chapter for more details.

## 5.11 NFC Electrical Specification

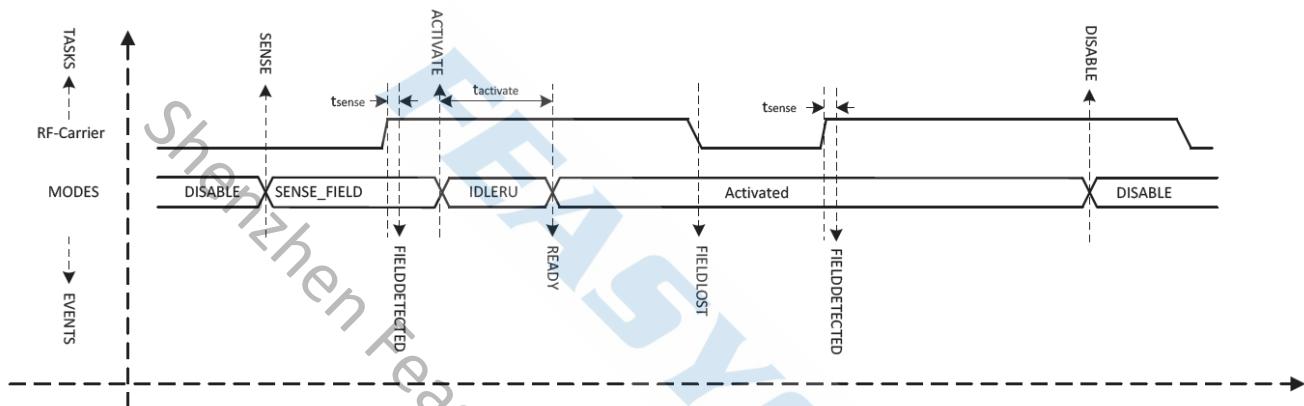
Table 21: NFC Electrical Specification

| Parameter                 |  | Min | Typ   | Max | Unit |
|---------------------------|--|-----|-------|-----|------|
| f <sub>c</sub> -          | Frequency of operation   | -   | 13.56 | -   | MHz  |
| CMI -                     | Carrier modulation index   | 95  | -     | -   | %    |
| DR -                      | Data Rate  | -   | 106   | -   | kbps |
| f <sub>s</sub> -          | Modulation sub-carrier frequency   | -   | fc/16 | -   | MHz  |
| V <sub>swing</sub>        | Peak differential Input voltage swing on NFC1 and NFC2                   | -   | -     | VDD | Vp   |
| V <sub>sense</sub> -      | Peak differential Field detect threshold level on NFC1-NFC2 <sup>a</sup> | -   | 1.0   | -   | Vp   |
| I <sub>sense</sub> -      | Current in SENSE STATE   | -   | 100   | -   | nA   |
| I <sub>activated</sub> -  | Current in ACTIVATED STATE   | -   | 480   | -   | uA   |
| R <sub>in_min</sub> -     | Minimum input resistance when regulating voltage swing                   | -   | -     | 40  | Ω    |
| R <sub>in_max</sub> -     | Maximum input resistance when regulating voltage swing                   | 1.0 | -     | -   | kΩ   |
| R <sub>in_loadmod</sub> - | Input resistance when load modulating                                    | 8   | -     | 22  | Ω    |
| I <sub>max</sub> -        | Maximum input current on NFC pins  | -   | -     | 80  | mA   |

a: Input is high impedance in sense mode

**Table 22:** NFCT Timing Parameters

| Parameter  |  | Min | Typ | Max | Unit |
|--|--|-----|-----|-----|------|
| $t_{activate}$ - Time from task_ACTIVATE in SENSE or DISABLE state to ACTIVATE_A or IDLE stateb  |  | -   | -   | 500 | uS   |
| $t_{sense}$ - Time from remote field is present in SENSE mode to FIELDDETECTED event is asserted |  | -   | -   | 20  | uS   |
| b: Does not account for voltage supply and oscillator startup times                              |  |     |     |     |      |

**Figure 42:** NFCT timing parameters (Shortcuts for FIELDDETECTED and FIELDLOST are disabled)

## 5.12 Power consumptions

**Table 23:** Power consumptions (TBD)

| Parameter               | Test Conditions  | Type                 | Unit |
|-------------------------|--|----------------------|------|
| TX & RX                 | peak current in TX (0 dBm)<br>peak current in TX (4 dBm)<br>peak current in RX | ~5.3<br>~6.6<br>~5.4 | mA   |
| NFC antenna pin current | INF C1/2   | 80                   | mA   |

### Current consumption, sleep

|  |     |    |
|--|-----|----|
| $I_{OFF}$ - System OFF current, no RAM retention                     | 0.3 | uA |
| $I_{ON}$ - System ON base current, no RAM retention                  | 1.2 | uA |
| $I_{RAM}$ - Additional RAM retention current per 4 KB<br>RAM section | 20  | nA |

### Power fail comparator

|  |    |    |
|--|----|----|
| $I_{POF}$ - Current consumption when enabled | <4 | uA |
|--|----|----|

## 6. MSL & ESD

**Table 24:** MSL and ESD

| Parameter                        | Value   |
|----------------------------------|---|
| MSL (moisture sensitivity level) | MSL 1   |
| ESD grade:                       | ESD HBM (human body model): 2KV<br>ESD HBM (human body model): 500V |

## 7. RECOMMENDED TEMPERATURE REFLOW PROFILE

Prior to any reflow, it is important to ensure the modules were packaged to prevent moisture absorption. New packages contain desiccate (to absorb moisture) and a humidity indicator card to display the level maintained during storage and shipment. If directed to bake units on the card, please check the below **Table 25** and follow instructions specified by IPC/JEDEC J-STD-033.

**Note:** The shipping tray cannot be heated above 65°C. If baking is required at the higher temperatures displayed in the below **Table 25**, the modules must be removed from the shipping tray.

Any modules not manufactured before exceeding their floor life should be re-packaged with fresh desiccate and a new humidity indicator card. Floor life for MSL (Moisture Sensitivity Level) 3 devices is 168 hours in ambient environment 30°C/60%RH.

**Table 25:** Recommended baking times and temperatures

| MSL | 125°C Baking Temp.   |  | 90°C/≤ 5%RH Baking Temp. |  | 40°C/ ≤ 5%RH Baking Temp. |  |
|-----|----------------------|--|--------------------------|--|---------------------------|--|
|     | Saturated @ 30°C/85% | Floor Life Limit + 72 hours @ 30°C/60% | Saturated @ 30°C/85%     | Floor Life Limit + 72 hours @ 30°C/60% | Saturated @ 30°C/85%      | Floor Life Limit + 72 hours @ 30°C/60% |
| 3   | 9 hours              | 7 hours                                | 33 hours                 | 23 hours                               | 13 days                   | 9 days                                 |

Feasycom surface mount modules are designed to be easily manufactured, including reflow soldering to a PCB. Ultimately it is the responsibility of the customer to choose the appropriate solder paste and to ensure oven temperatures during reflow meet the requirements of the solder paste. Feasycom surface mount modules conform to J-STD-020D1 standards for reflow temperatures.

The soldering profile depends on various parameters necessitating a set up for each application. The data here is given only for guidance on solder reflow.

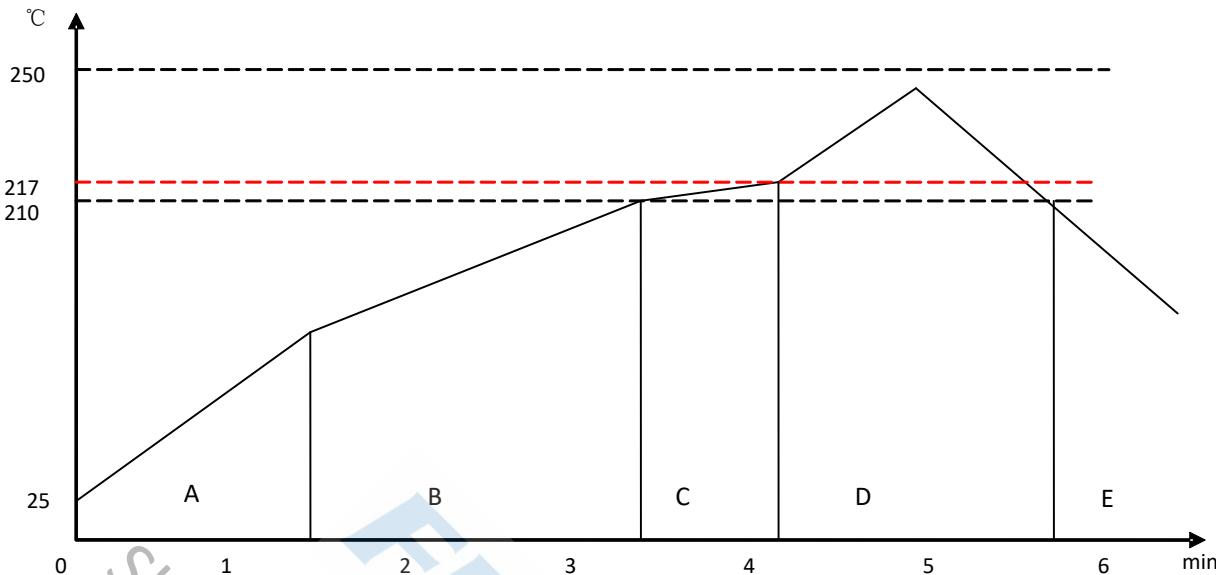


Figure 43: Typical Lead-free Re-flow

**Pre-heat zone (A)** — This zone raises the temperature at a controlled rate, typically  $0.5 - 2\text{ }^{\circ}\text{C/s}$ . The purpose of this zone is to preheat the PCB board and components to  $120 \sim 150\text{ }^{\circ}\text{C}$ . This stage is required to distribute the heat uniformly to the PCB board and completely remove solvent to reduce the heat shock to components.

**Equilibrium Zone 1 (B)** — In this stage the flux becomes soft and uniformly encapsulates solder particles and spread over PCB board, preventing them from being re-oxidized. Also with elevation of temperature and liquefaction of flux, each activator and rosin get activated and start eliminating oxide film formed on the surface of each solder particle and PCB board. **The temperature is recommended to be  $150^{\circ}$  to  $210^{\circ}$  for 60 to 120 second for this zone.**

**Equilibrium Zone 2 (C) (optional)** — In order to resolve the upright component issue, it is recommended to keep the temperature in  $210 - 217\text{ }^{\circ}$  for about 20 to 30 second.

**Reflow Zone (D)** — The profile in the figure is designed for Sn/Ag3.0/Cu0.5. It can be a reference for other lead-free solder. The peak temperature should be high enough to achieve good wetting but not so high as to cause component discoloration or damage. Excessive soldering time can lead to intermetallic growth which can result in a brittle joint. The recommended peak temperature ( $T_p$ ) is  $230 \sim 250\text{ }^{\circ}\text{C}$ . The soldering time should be 30 to 90 second when the temperature is above  $217\text{ }^{\circ}\text{C}$ .

**Cooling Zone (E)** — The cooling rate should be fast, to keep the solder grains small which will give a longer-lasting joint. **Typical cooling rate should be  $4\text{ }^{\circ}\text{C}$ .**

## 8. MECHANICAL DETAILS

### 8.1 Mechanical Details

- Dimension: 10mm(W) x 11.9mm(L) x 1.8mm(H) Tolerance:  $\pm 0.1\text{mm}$
- Module size: 10mm X 11.9mm Tolerance:  $\pm 0.1\text{mm}$
- Pad size: 0.9mmX0.6mm Tolerance:  $\pm 0.1\text{mm}$
- Pad pitch: 1.1mm Tolerance:  $\pm 0.1\text{mm}$

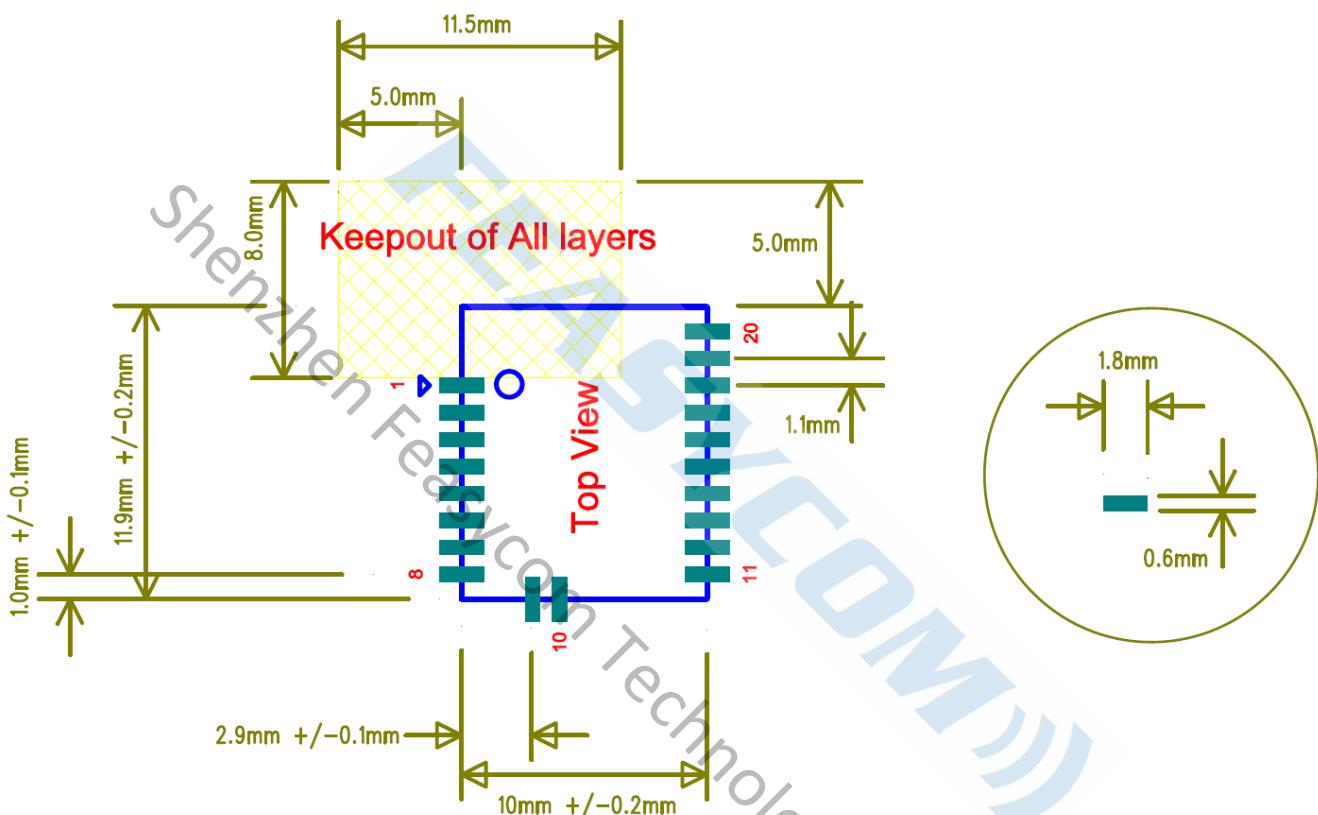


Figure 44: FSC-BT630 footprint

## 9. HARDWARE INTEGRATION SUGGESTIONS

### 9.1 Soldering Recommendations

FSC-BT630 is compatible with industrial standard reflow profile for Pb-free solders. The reflow profile used is dependent on the thermal mass of the entire populated PCB, heat transfer efficiency of the oven and particular type of solder paste used. Consult the datasheet of particular solder paste for profile configurations.

Feasycom will give following recommendations for soldering the module to ensure reliable solder joint and operation of the module after soldering. Since the profile used is process and layout dependent, the optimum profile should be studied case by case. Thus following recommendation should be taken as a starting point guide.

## 9.2 Layout Guidelines(Internal Antenna)

It is strongly recommended to use good layout practices to ensure proper operation of the module. Placing copper or any metal near antenna deteriorates its operation by having effect on the matching properties. Metal shield around the antenna will prevent the radiation and thus metal case should not be used with the module. Use grounding vias separated max 3 mm apart at the edge of grounding areas to prevent RF penetrating inside the PCB and causing an unintentional resonator. Use GND vias all around the PCB edges.

The mother board should have no bare conductors or vias in this restricted area, because it is not covered by stop mask print. Also no copper (planes, traces or vias) are allowed in this area, because of mismatching the on-board antenna.

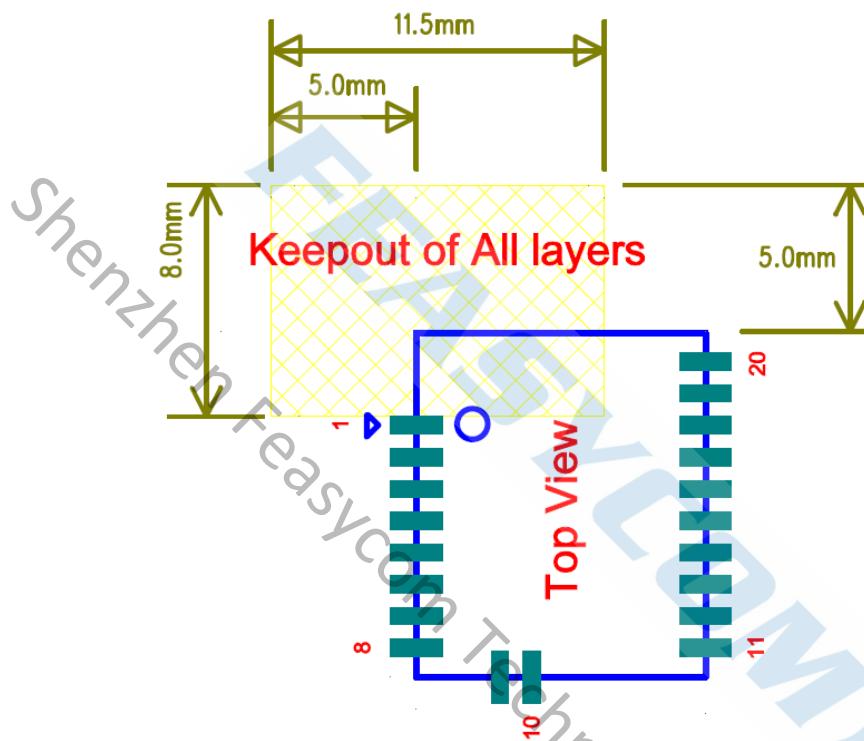


Figure 45: FSC-BT630 Restricted Area (keepout of all layers)

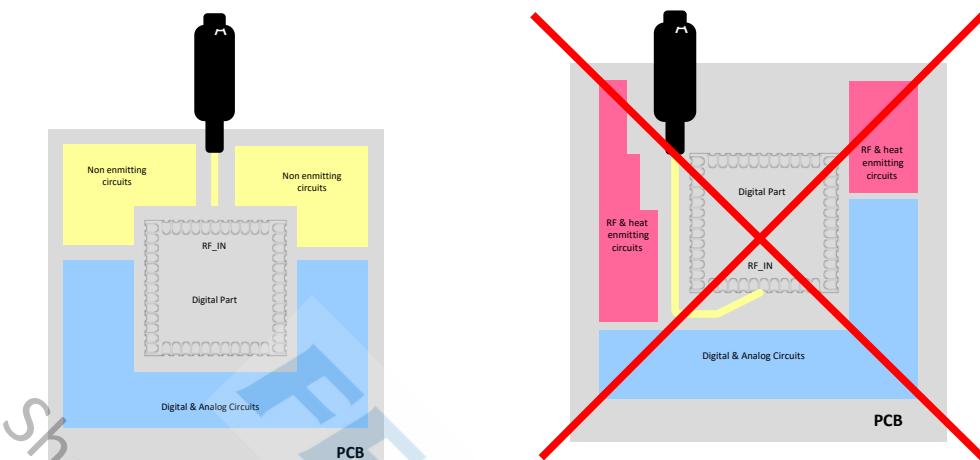
Following recommendations helps to avoid EMC problems arising in the design. Note that each design is unique and the following list do not consider all basic design rules such as avoiding capacitive coupling between signal lines. Following list is aimed to avoid EMC problems caused by RF part of the module. Use good consideration to avoid problems arising from digital signals in the design.

Ensure that signal lines have return paths as short as possible. For example if a signal goes to an inner layer through a via, always use ground vias around it. Locate them tightly and symmetrically around the signal vias. Routing of any sensitive signals should be done in the inner layers of the PCB. Sensitive traces should have a ground area above and under the line. If this is not possible, make sure that the return path is short by other means (for example using a ground line next to the signal line).

## 9.3 Layout Guidelines(External Antenna)

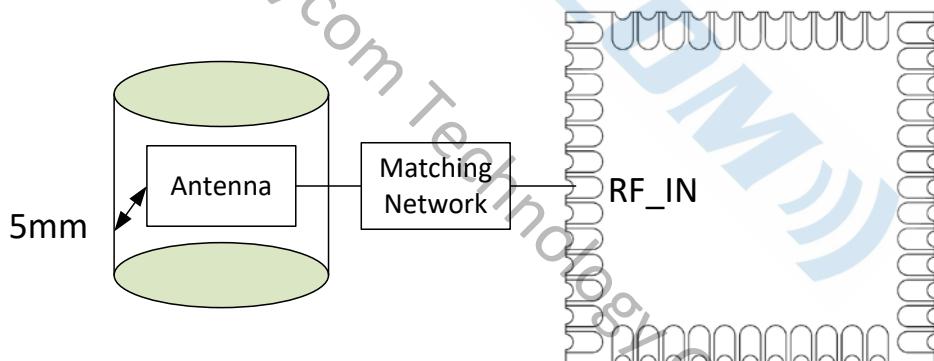
Placement and PCB layout are critical to optimize the performances of a module without on-board antenna designs. The trace from the antenna port of the module to an external antenna should be  $50\Omega$  and must be as short as possible to avoid any interference into the transceiver of the module. The location of the external antenna and RF-IN port of the module should be kept away from any noise sources and digital traces. A matching network might be needed in between the external antenna and RF-IN port to better match the impedance to minimize the return loss.

As indicated in **Figure 46** below, RF critical circuits of the module should be clearly separated from any digital circuits on the system board. All RF circuits in the module are close to the antenna port. The module, then, should be placed in this way that module digital part towards your digital section of the system PCB.



**Figure 46:** Placement the Module on a System Board

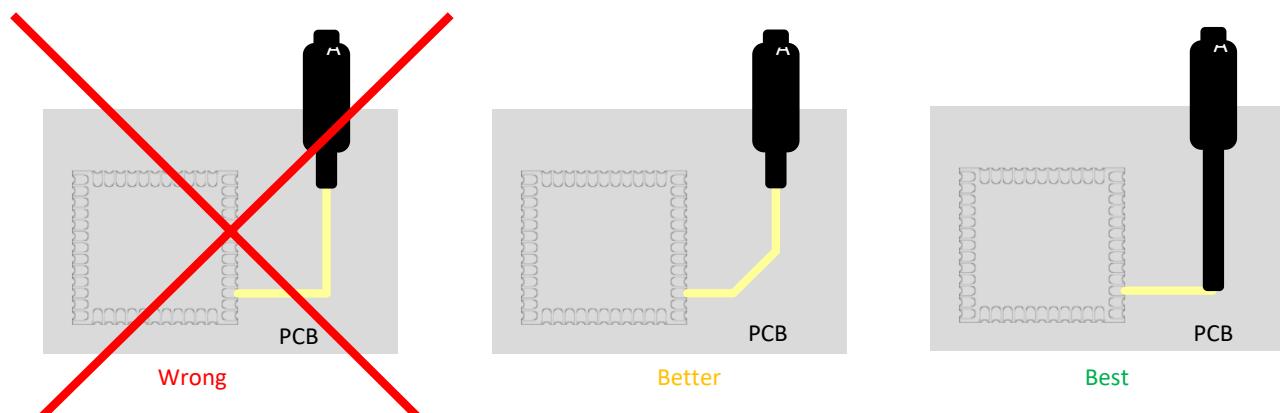
### 9.3.1 Antenna Connection and Grounding Plane Design



**Figure 47:** Leave 5mm Clearance Space from the Antenna

General design recommendations are:

- The length of the trace or connection line should be kept as short as possible.
- Distance between connection and ground area on the top layer should at least be as large as the dielectric thickness.
- Routing the RF close to digital sections of the system board should be avoided.
- To reduce signal reflections, sharp angles in the routing of the micro strip line should be avoided. Chamfers or fillets are preferred for rectangular routing; 45-degree routing is preferred over Manhattan style 90-degree routing.



**Figure 48:** Recommended Trace Connects Antenna and the Module

- Routing of the RF-connection underneath the module should be avoided. The distance of the micro strip line to the ground plane on the bottom side of the receiver is very small and has huge tolerances. Therefore, the impedance of this part of the trace cannot be controlled.
- Use as many vias as possible to connect the ground planes.

## 10. PRODUCT PACKAGING INFORMATION

### 10.1 Default Packing

a, Tray vacuum

b, Tray Dimension: 180mm \* 195mm





Figure 49: Tray vacuum (Image for reference only, subject to actual product)

## 11. CERTIFICATION

### 11.1 Certificate picture

Has passed FCC, CE, IC, KC and SRCC certification.

**TCB**

GRANT OF EQUIPMENT AUTHORIZATION  
Certification  
Issued Under the Authority of the Federal Communications Commission  
By:

Timco Engineering, Inc.  
849 NW State Road 45  
Newberry, FL 32669

**TCB**

Date of Grant: 04/16/2019  
Application Dated: 04/16/2019

Shenzhen Feasycom Technology Co.,Ltd  
Room 2004A, 20th Floor, Huichao Technology Building, Jinhai Road, Xixiang, Baoan District., Shenzhen, China

Attention: Wan Zhiyu

#### NOT TRANSFERABLE

EQUIPMENT AUTHORIZATION is hereby issued to the named GRANTEE, and is VALID ONLY for the equipment identified hereon for use under the Commission's Rules and Regulations listed below.

FCC IDENTIFIER: 2AMWOFSC-BT630

Name of Grantee: Shenzhen Feasycom Technology Co., Ltd

Equipment Class: Digital Transmission System

Notes: Bluetooth Module

Modular Type: Single Modular

Grant Notes:

FCC Rule Parts

15C

Frequency Range (MHz)

2402.0 - 2480.0

Output Watts

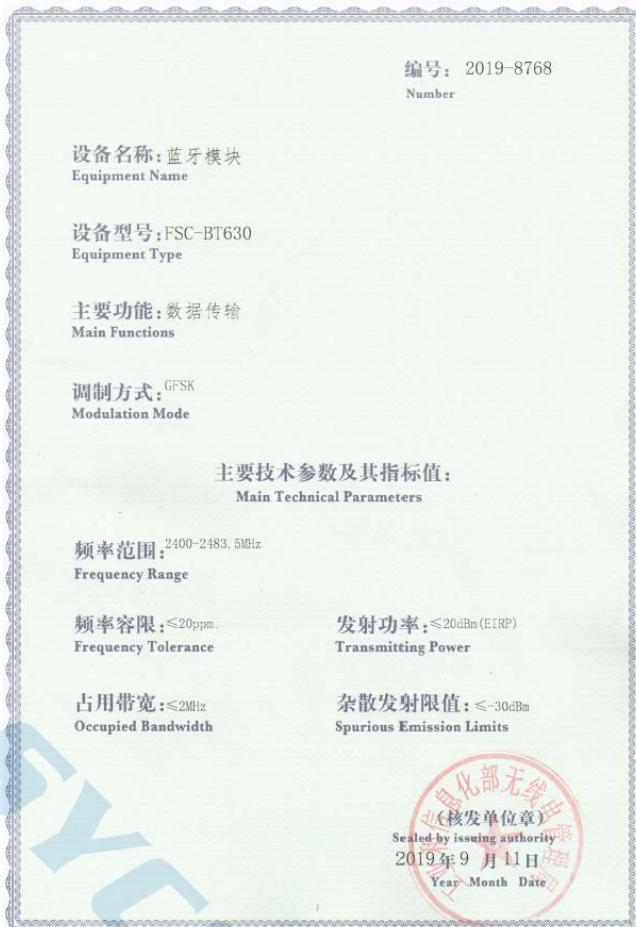
0.001

Frequency Tolerance

Emission Designator

Single Modular Approval. Power listed is conducted. Approval is limited to OEM installation only. Compliance of this device in all final host configurations is the responsibility of the Grantee. This device is to be used only for mobile and fixed applications. The module must be installed to provide a 20 cm separation distance between the radiating element of the module and all persons. OEM integrators must be provided with labeling requirements for finished products. OEM integrators and end-Users must be provided with transmitter operation conditions for satisfying RF exposure compliance. This grant is valid only when the device is sold to OEM integrators and the OEM integrators are instructed to ensure that the end user has no manual instructions to remove or install the device. Separate approval is required for all other operating configurations, including portable configurations with respect to 2.1093 and different antenna configurations.





| B7BE-88A8-1901-9675   |  |
|---|--|
| 방송통신기자재등의 적합인증서<br>Certificate of Broadcasting and Communication Equipments   |  |
| 상호 또는 성명<br>Trade Name or Appointee   | Shenzhen Feasycom Technology Co., LTD  |
| 기자재명칭(영문)<br>Equipment Name   | 특정소출역 무선기기(무선테이티통신시스템용 무선기기)   |
| 기본모델명<br>Basic Model Number   | FSC-BT630  |
| 파생모델명<br>Sales Model Number   |  |
| 인증번호<br>Certification No.   | R-C-fes-FSC-BT630  |
| 제조자/제조국가<br>Manufacturer/<br>Country of Origin  | Shenzhen Feasycom Technology Co., LTD / 중국   |
| 인증연월일<br>Date of Certification  | 2020-06-26   |
| 기타<br>Others  | 위 기자재는 「선파법」 제58조의2 제2항에 따라 인증되었음을 증명합니다.<br>It is verified that foregoing equipment has been certified under the Clause 2, Article 58-2 of Radio Waves Act. |
| 2020년(Year) 06월(Month) 26일(Day)   |  |
| <br>국립전파연구원장<br>Director General of National Radio Research Agency |  |
| ※ 인증 받은 방송통신기자재는 반드시 "적합성 평가표지"를 부착하여 유통하여야 합니다.<br>위 표지와 함께 청탁 및 인증이 취소될 수 있습니다.   |  |

## 12. APPLICATION SCHEMATIC

